

SiPM: How to Make it an ideal LLL Sensor

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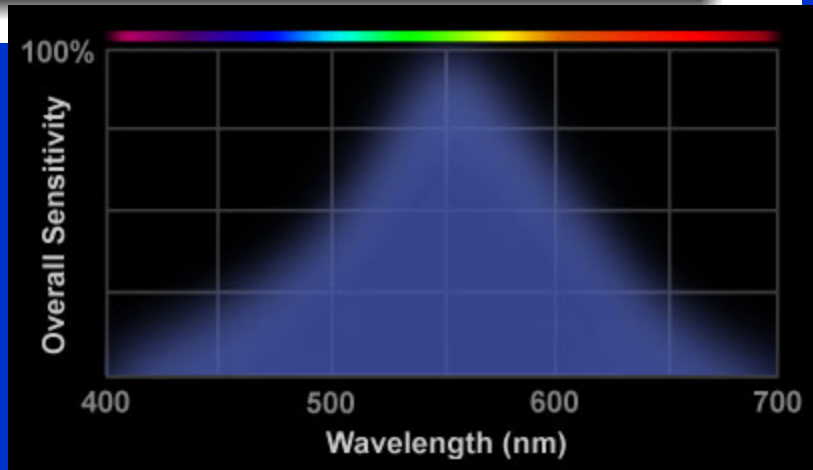
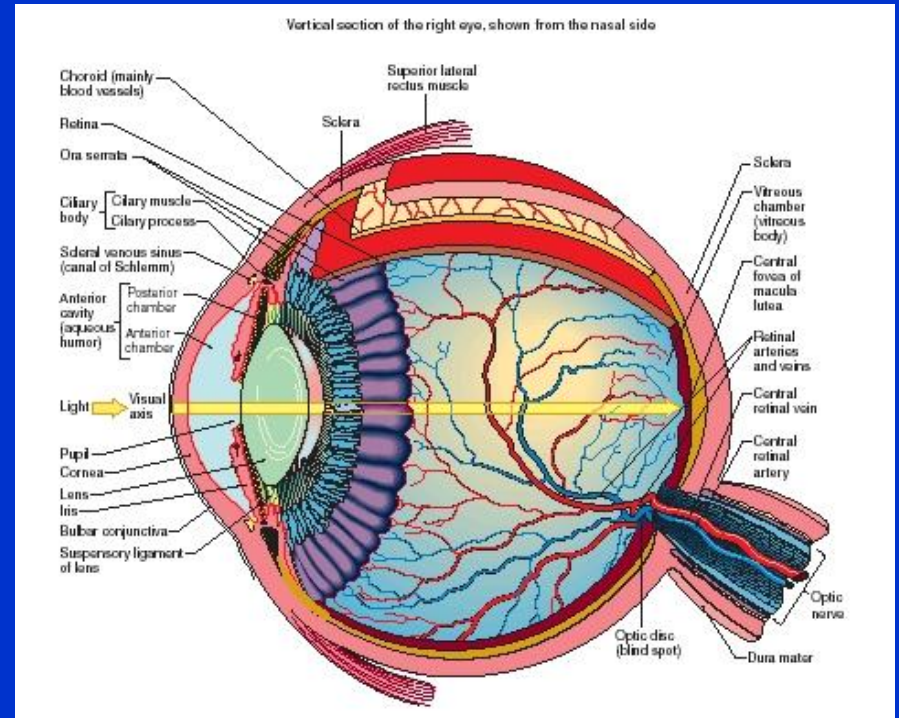
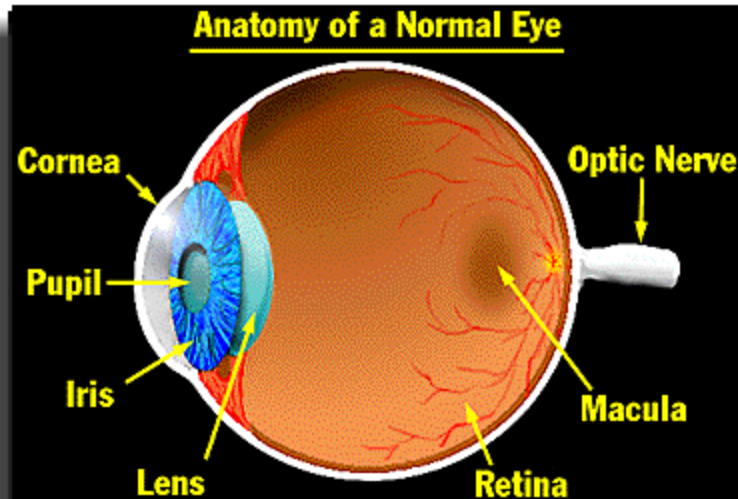
The most complex light sensors



These seemingly best-known imaging light sensors measure colour in the a relatively wide band (400 – 700 nm) as well as the light intensity within a

- dynamic range of 13 orders of magnitude !
- angular resolution $\sim 1'$ (oculists call it 100 % sight)
- integration time ≥ 30 ms,
- threshold value for signals
 - 5-7 green photons (after few hours adaptation in the darkness)
 - 30 photons on average in the dark

Complex light sensors



What LLL sensor can we dream about ?

- Die eierlegende Woll-Milch-Sau (german)
(approximate english translation: all-in-one device suitable for every purpose)



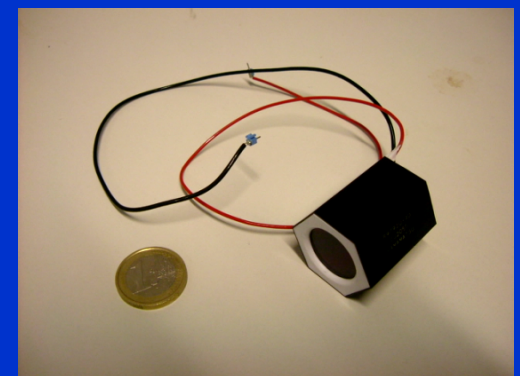
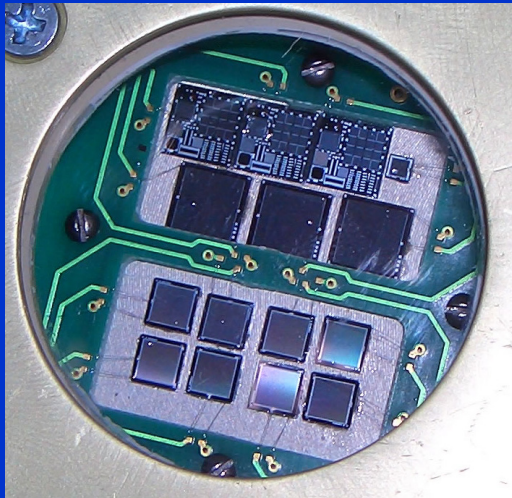
What LLL sensor can we dream about ?

- Nearly 100 % QE and photon detection efficiency (PDE)
- Could be made in very large and in very small sizes
- Few ps fast (in air and in many materials the light speed is usually 20-30 cm/ns; in 5 ps it will make 1-1.5 mm)
- Signal amplification $\times 10^6$
- Noiseless amplification: F-factor - 1.001
- Few % amplitude resolution
- No fatigue, no degradation in lifetime
- Low power consumption
- Operation at ambient temperatures
- No danger to expose to light
- Insensitive to magnetic fields
- No vacuum, no HV, lightweight,...

Light conversion into a measurable

- Visible light can react and become measurable by:
 - ◆ Eye (*human: $QE \sim 3 \%$ & animal*), plants, paints,...
 - ◆ Photoemulsion ($QE \sim 0.1 - 1 \%$) (photo-chemical)
 - ◆ Photodiodes (photoelectrical, evacuated)
 - ◆ Classical & hybrid photomultipliers ($QE \sim 25 \%$)
 $QE \sim 45 \%$ (HPD with GaAsP photocathode)
 - ◆ Photodiodes ($QE \sim 70 - 80 \%$) (photoelectrical)
 - ◆ PIN diodes, Avalanche diodes, SiPM,...
 - ◆ photodiode arrays like CCD, CMOS cameras,...

The „zoo“ of LLL sensors

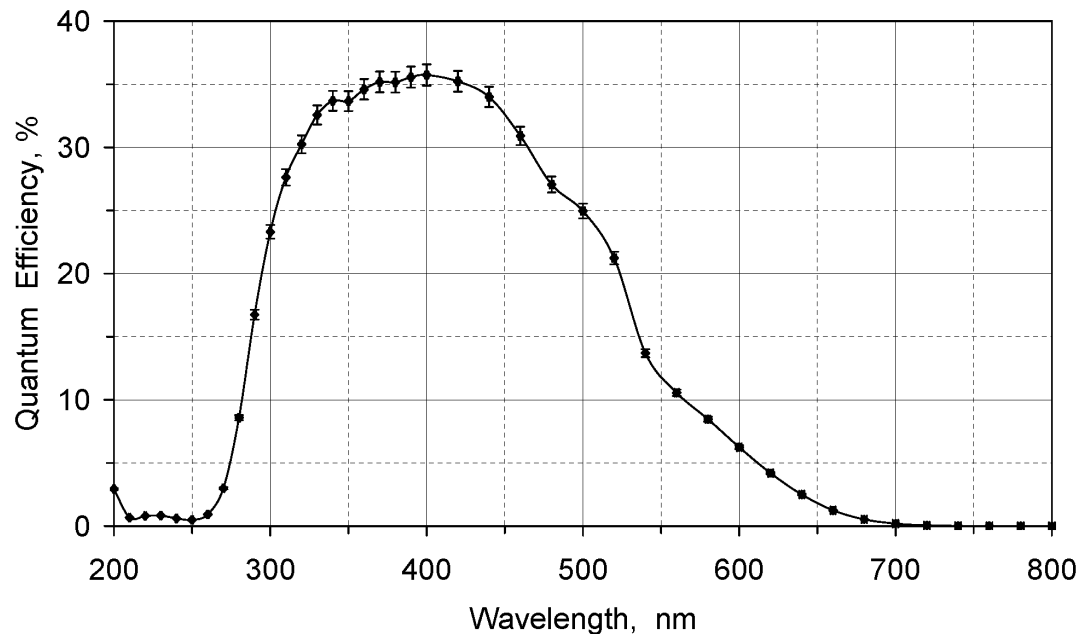


Thursday 4th September
2008

R. Mirzoyan: SiPM: How to Make
it an Ideal LLL Sensor; FermiLab

The beginning of the bialkali PMT QE enhancement program

Mirzoyan, et al., NIM A 567 (2006)

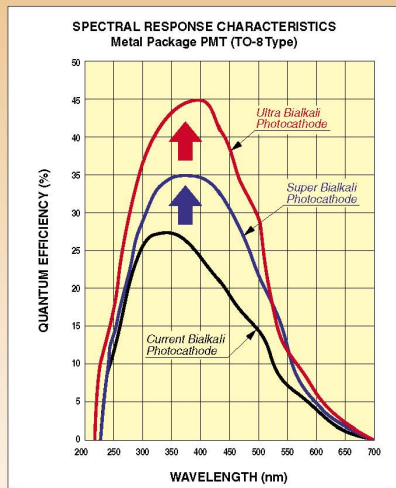


2" PMT from Hamamatsu

Recent Surprises

TECHNICAL INFORMATION

Ultra Bialkali Photocathode (UBA): QE 43% typ.
Super Bialkali Photocathode (SBA): QE 35% typ.



Photocathode	QE at peak wavelength		Type Availability
	Min.	Typ.	
Ultra Bialkali (UBA)	36 %	43 %	Metal Package PMT (TO-8 Type, □28 mm Type PMT)
Super Bialkali (SBA)	32 %	35 %	Metal Package PMT (TO-8 Type, □28 mm Type PMT) φ28 mm to φ76 mm Head-on PMT (Glass Bulb Type)

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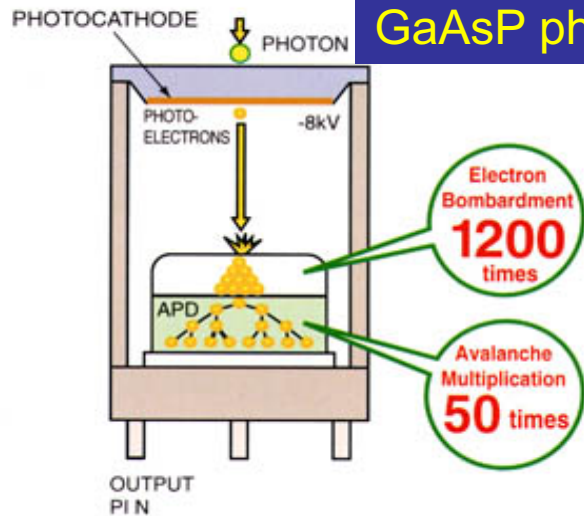
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 Germany: Hamamatsu Photonics Deutschland GmbH, Amberg-Heidegasse, 10, D-92011 Hamberg, Germany, Telephone: (49)9152-2551, Fax: (49)9152-2558, E-mail: info@hamamatsu.de
 France: Hamamatsu Photonics France S.A.R.L., 19, Rue de la Vallée, Parc de la Vallée de la Mère, 91282 Massy Cedex, France, Telephone: (33)1 69 52 71 01, Fax: (33)1 69 52 71 01, E-mail: info@hamamatsu.fr
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 North Europe: Hamamatsu Photonics Norden AB, Smedevägen 12, SE-171 41 SOLNA, Sweden, Telephone: (46)8-909-03-00, Fax: (46)8-909-03-01, E-mail: info@hamamatsu.se
 Italy: Hamamatsu Photonics Italia S.p.A., Strada della Mole, 15, 20090 Sesto San Giovanni (MI), Italy, Telephone: (39)02-260-6173, Fax: (39)02-260-6174, E-mail: info@hamamatsu.it

OCT. 2006 JIP
 Printed in Japan (1/000)

- All the 3 PMT manufacturers could report enhanced QE, the best being Hamamatsu, who gave it the name „Super-bialkali“ (QE~ 33-36 %) (Mirzoyan, et al., NIM A 572 (2007))
- ~2 years ago Hamamatsu claimed to produce PMTs with QE 43-45 % ! (once the *djinn* comes out of the lamp you cannot control it anymore) ;-)
- Recently also Photonis joined club of „Ultra-bialkali“. Moreover, it pushed the QE values even higher up !

R9792U-40, 18mm GaAsP HPD by Hamamatsu for MAGIC future camera

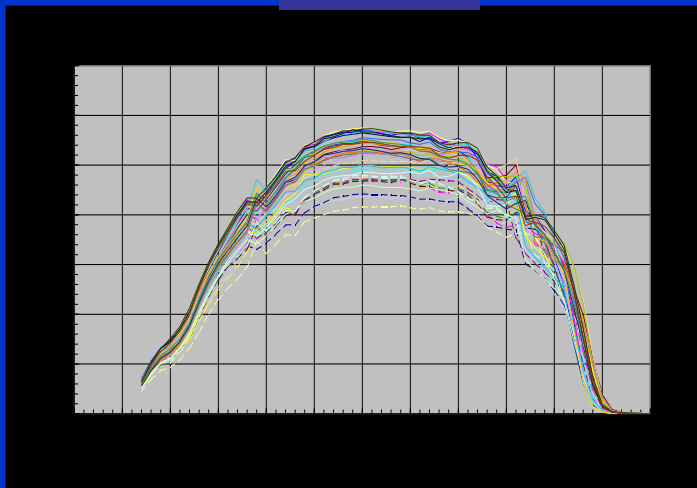
Compact HPD Operating Principle



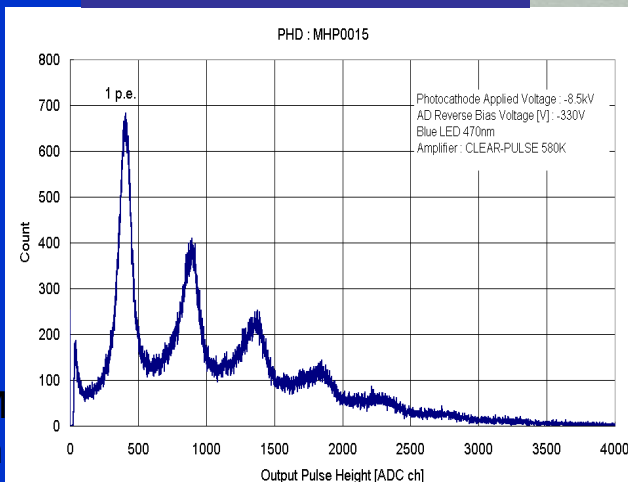
GaAsP photocathode



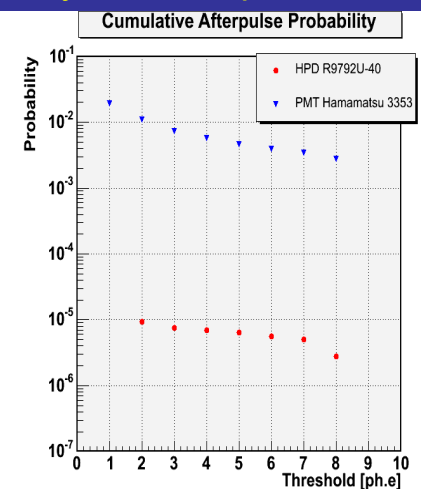
High Q.E.



Good Charge Resolution

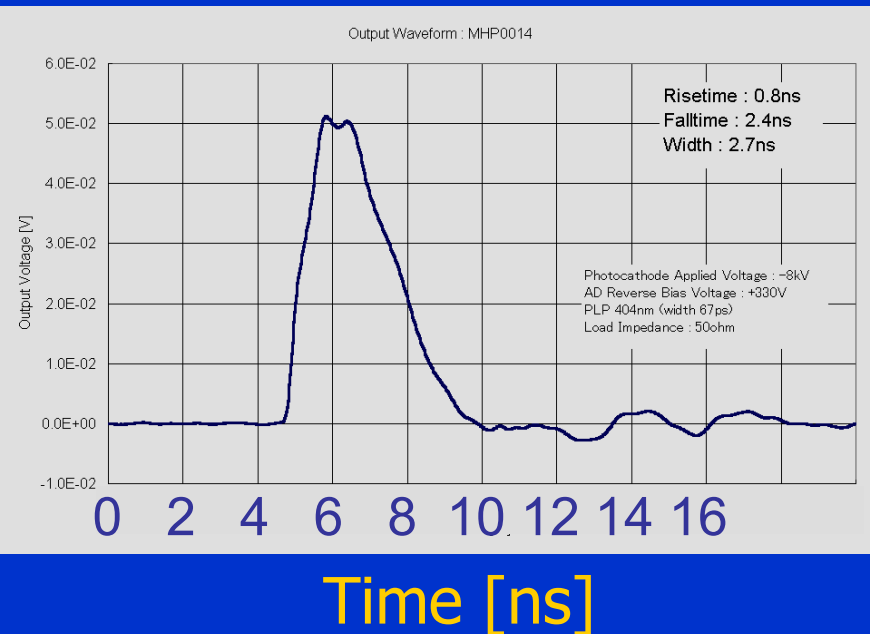


Very low after pulse rate



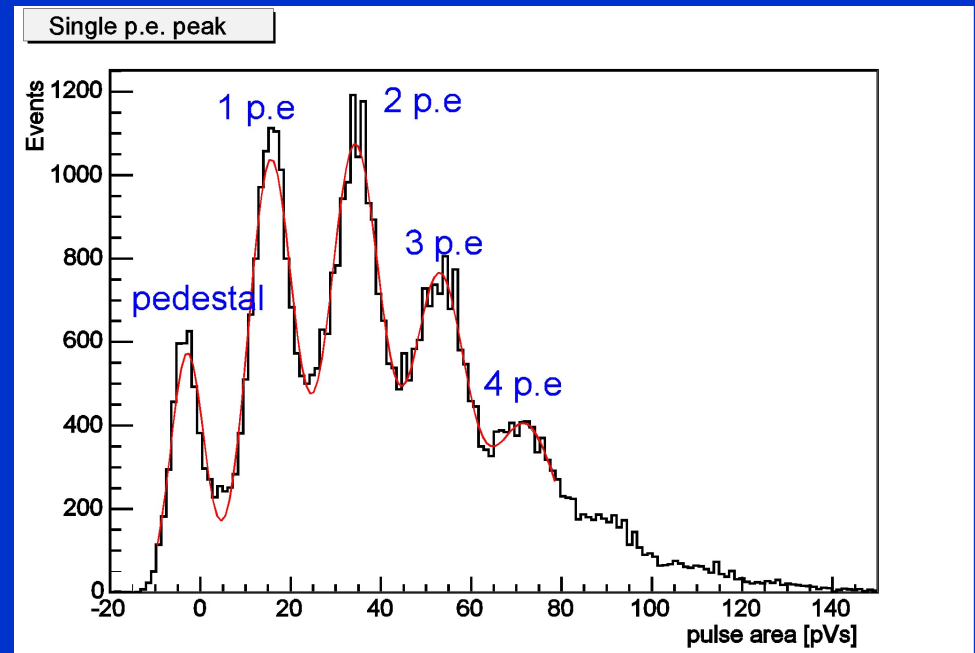
HPD Output Signal

<pulse shape>

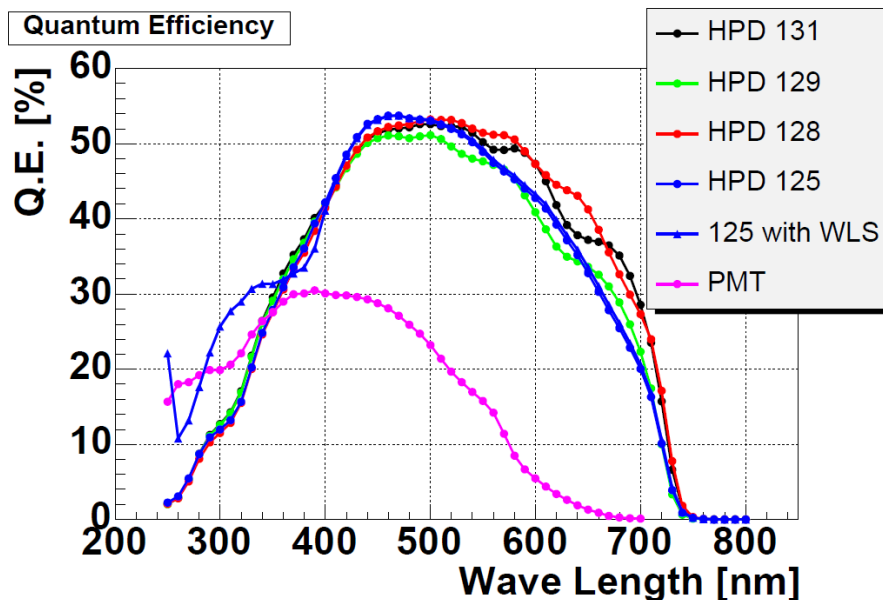


FWHM ~ 2.7 ns

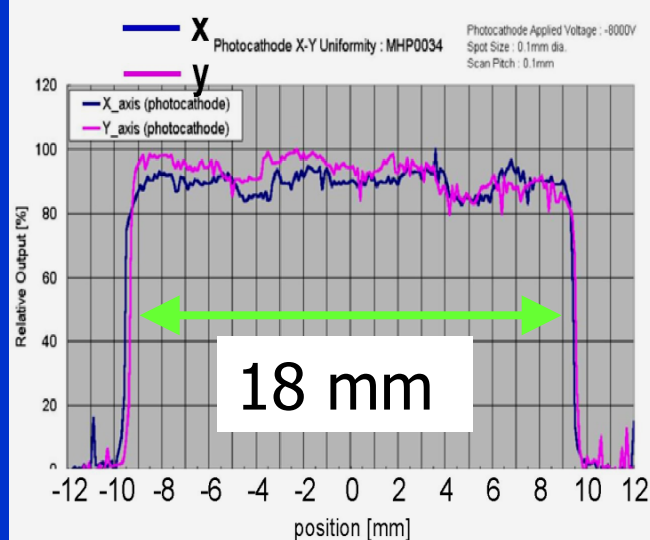
<pulse height distribution>



GaAsP HPD from Hamamatsu

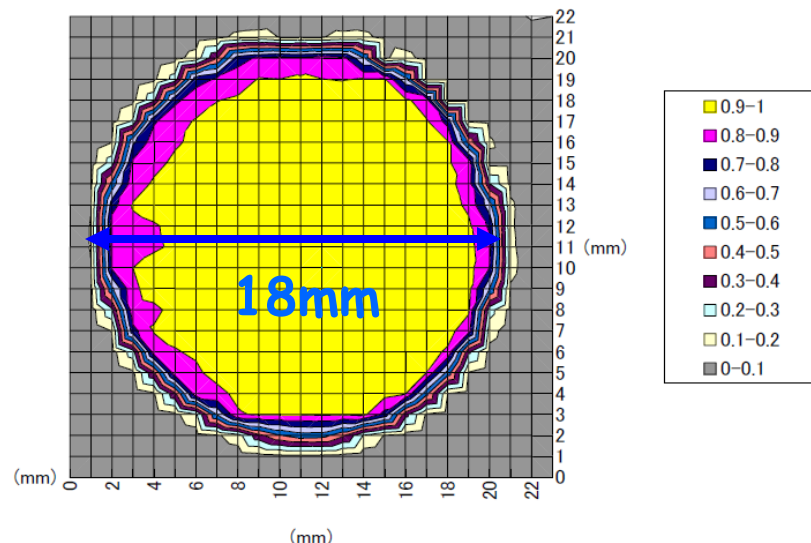


QE exceeds 50% at 450 nm
Two times higher photon detection



Photocathode voltage: -8000V, AD reverse bias voltage: +439V

Wavelength: 406nm, Spot size: 1mm, Scan pitch: 1mm



Good Uniformity. 18mm diameter
Within 10%.

The 17m Ø MAGIC IACT project for VHE γ astrophysics at $E \sim 25 \text{ GeV} - 30 \text{ TeV}$

www.magic.mppmu.mpg.de



Thursday 4th September
2008

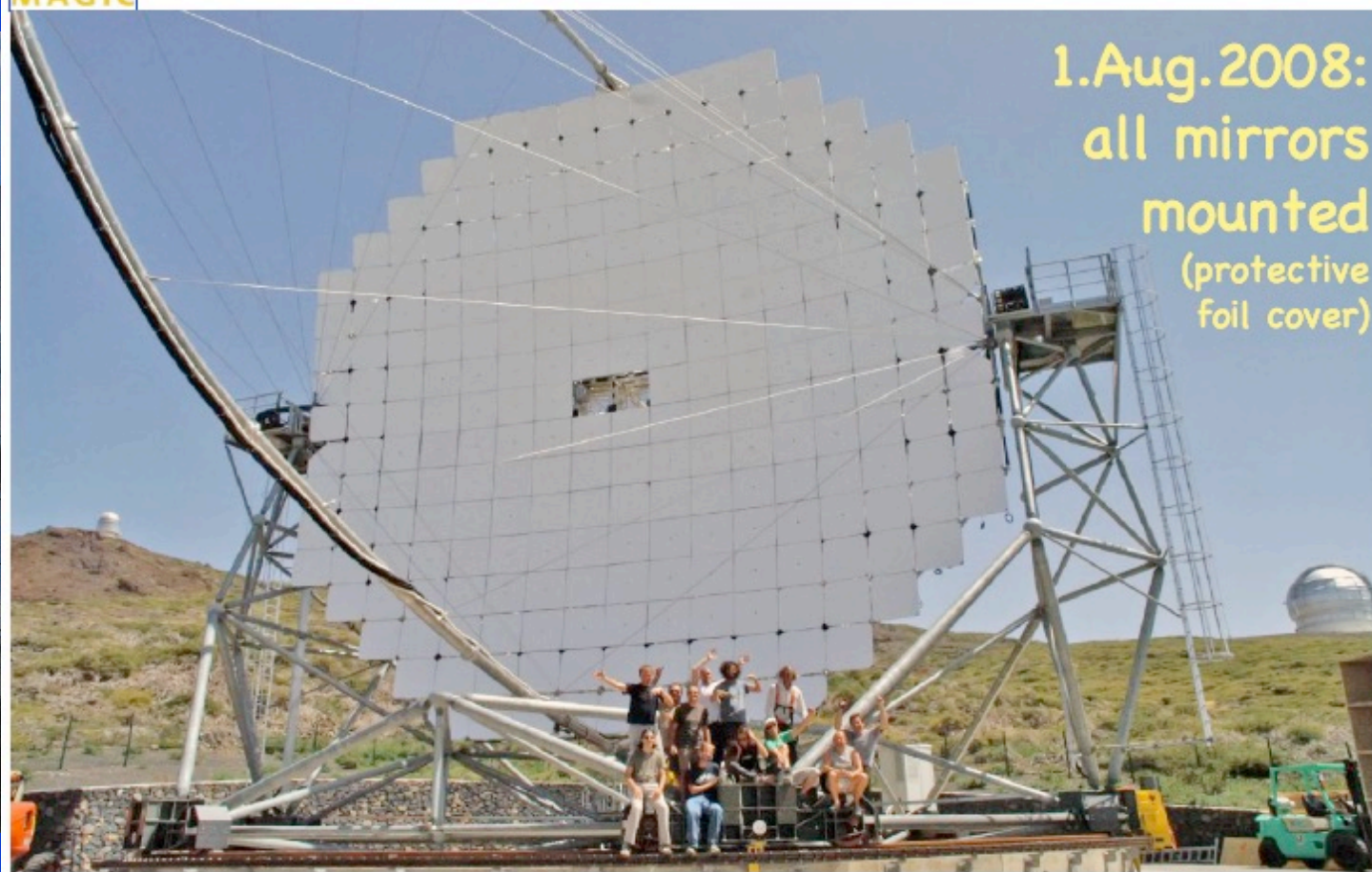
R. Mirzoyan: SiPM: How to Make
it an Ideal LLL Sensor; FermiLab

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The MAGIC Project



MAGIC-II



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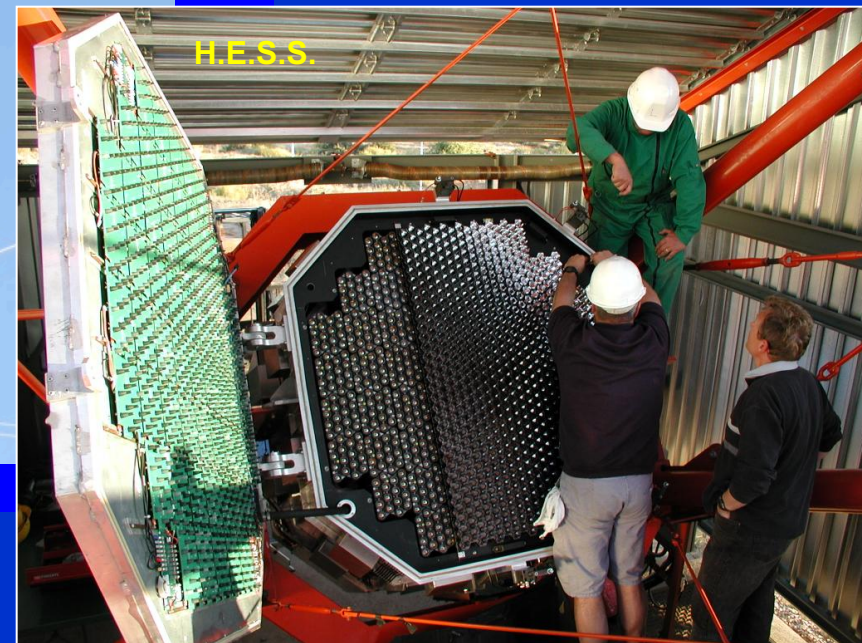
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hold

Photograph of the 576-pixel imaging camera of MAGIC-I. In the central part one can see the 396 high resolution pixels of 0.10° size. Those are surrounded by 180 pixels of 0.20° .



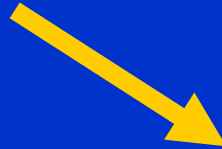
Outlook : the next 5-7 years

Next generation VHE γ ray Observatory: CTA

MAGIC Phase II (MAGIC-I + MAGIC-II) in 2008
50-100 sources will be discovered



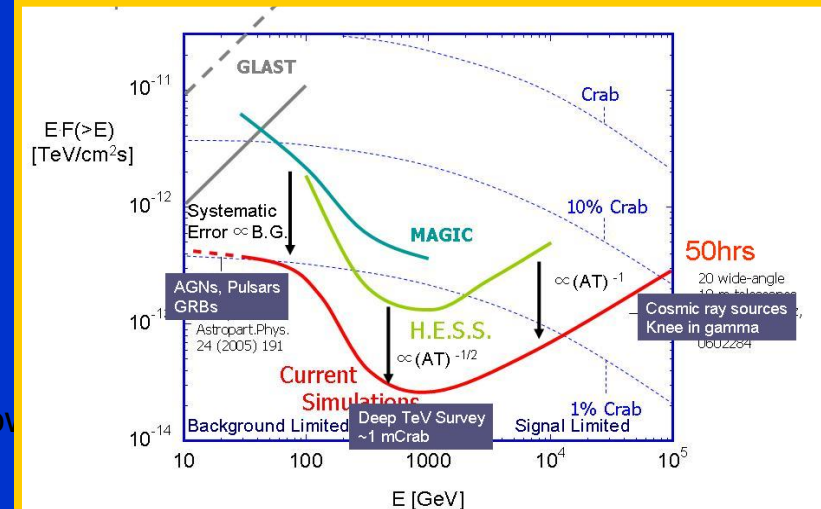
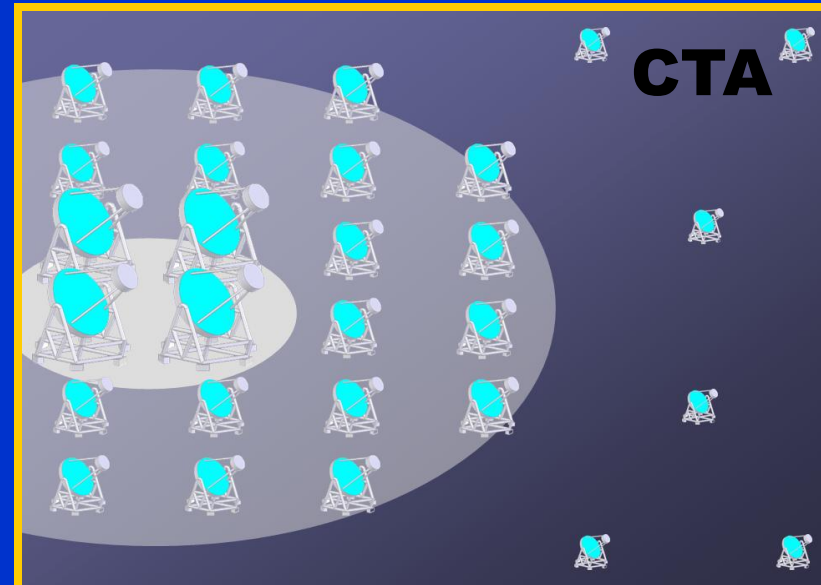
~400 scientists
~50 institutions



HESS Phase II (HESS + 28m Telescope) in 2009



Cherenkov Telescope Array
1000's of sources will be discovered



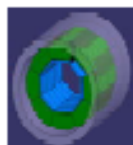
Astronomers in EU

JAPAN, US

Thursday 4th September 2009
D. Mirzoyan: SiPM: How to make an
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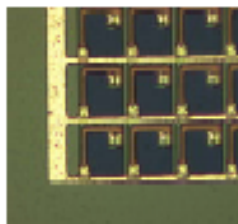
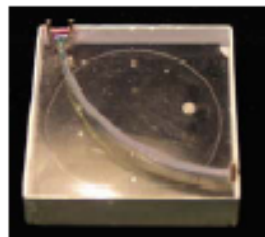
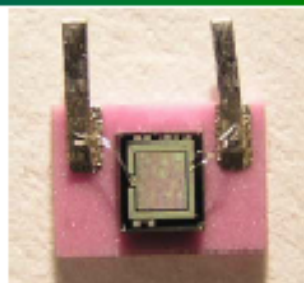
A Potential Sensor for ILC: $(5-200) \times 10^6$ SiPMs

- Scintillation Calorimetry- for instance a SciTile Imagine Hadron Calorimeter for ILC (CALICE Collaboration), sci tile size: a few cm
- Typical threshold is $\sim 5-7$ phe

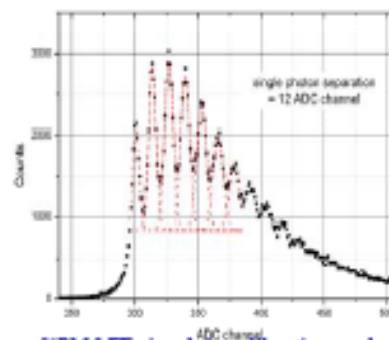


SiPM tile fibre system

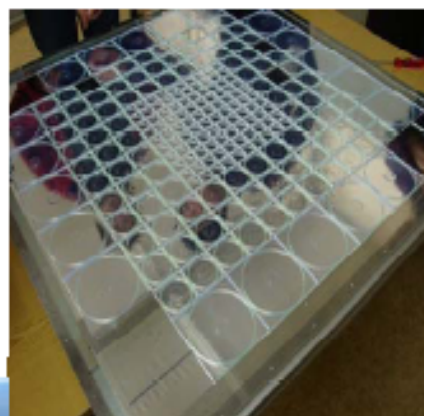
- SiPM developed by MEPhI/PUSAR
 - Gain $\sim 10^6$, bias ~ 50 V, size 1 mm^2 , 1156 pixels
 - Eff (green) $\sim 15\%$, quenching $R \sim 1 - 10 \text{ M}\Omega$
- SiPM tile fibre system integration: ITEP
 - $3 \times 3 \times 0.5 \text{ cm}^3$ tiles from UNIPLAST, Russia
 - WLS fibre Kuraray Y11(300) 1mm
 - Matted edges, 2% light xtalk per edge
 - Faces covered with EM mirror foil



A big 8000 channel HCAL prototype with tail catcher is constructed by CALICE (DESY, ITEP, LAL, MEPhI, NIU, Prague, UK) for analogue and semidigital modes

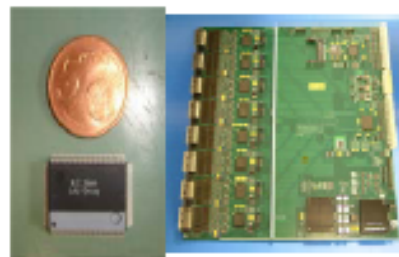


SiPM&FE signals in calibration mode



One plane with SiPMs and WLS fibers installed into 3×3 , 6×6 and $12 \times 12 \text{ cm}^2$ 0.5 cm thick tiles

CERN test beam, 2006



LAL 18 ch. SiPM
FE chip

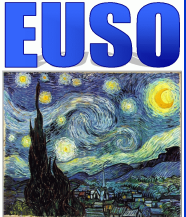


WIPs for calorimetry

Felix Seflow PD'07 June 27, 2007 13

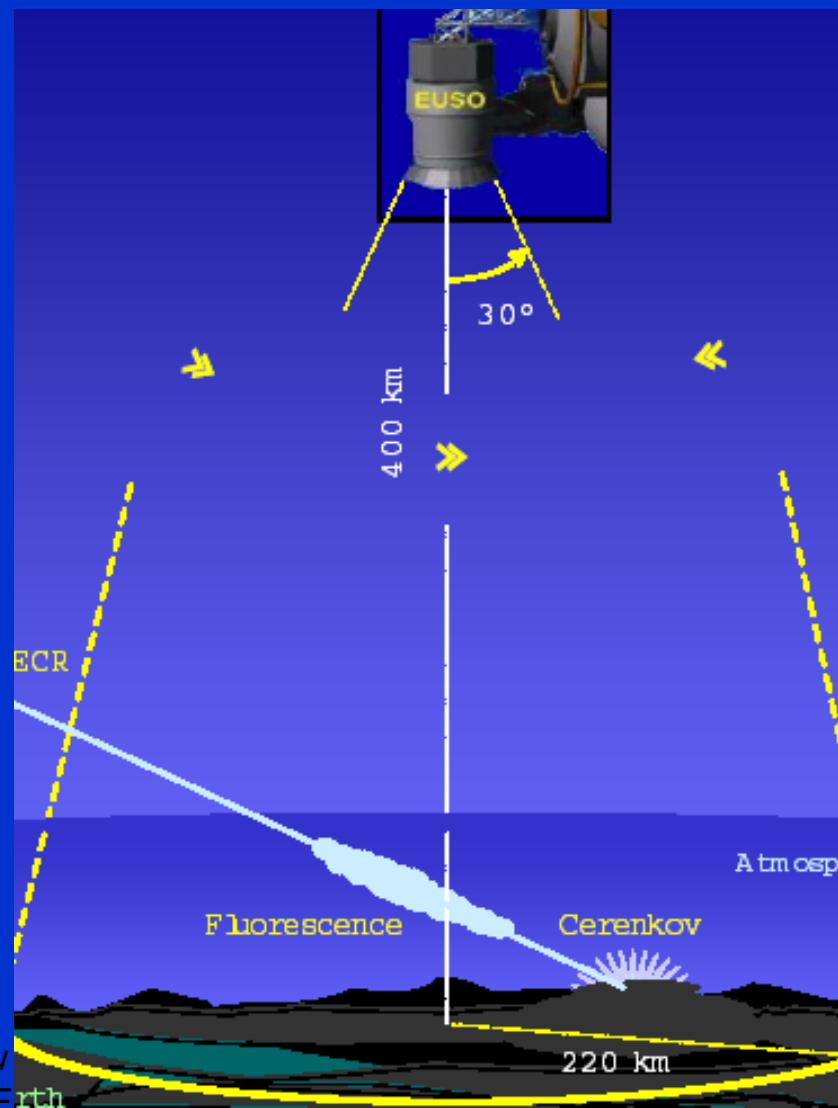
B. Dolgoshein, SiPM review

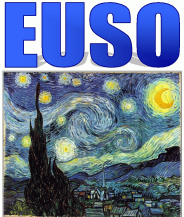
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(JEM)EUSO Concept

- Large Distance and Large F.O.V.
→ Large Aperture
 - $\sim 4.5 \times 10^5 \text{ km}^2 \text{ sr}$
 - Good Cosmic Ray detector
 - 3000 times sensitive to C.R. bursts
 - 1500 Giga-ton atmosphere
 - Good neutrino detector
- All Sky coverage
 - North and south sky covered
- Complementary to the observation from the ground
 - Different energy scale
 - Different systematic errors
- Shower Geometry is well defined

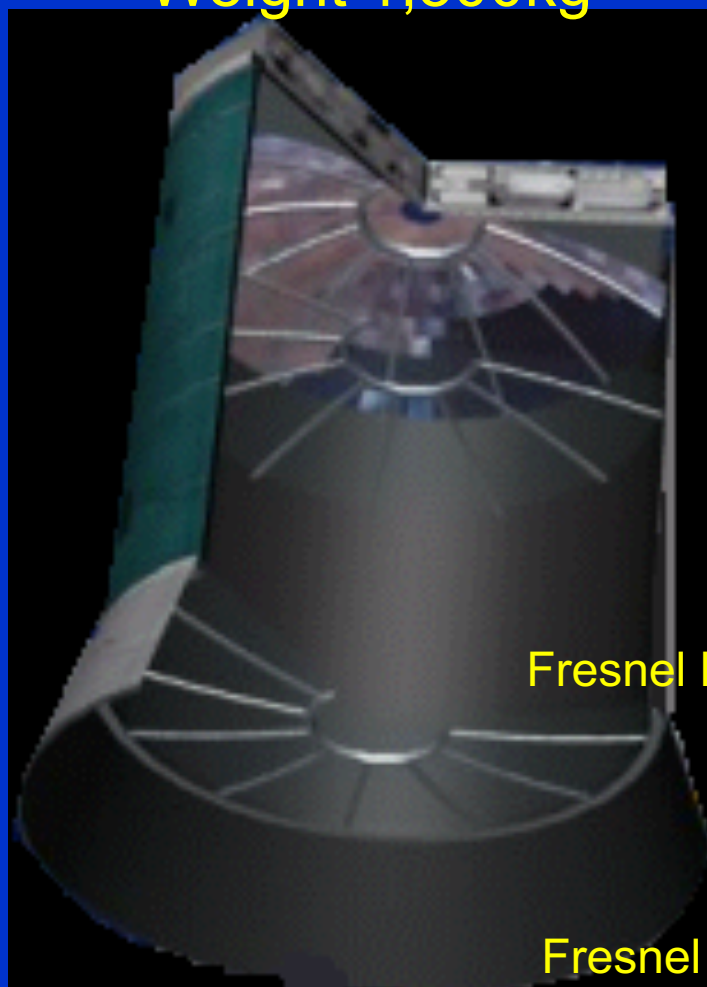




Detector Element

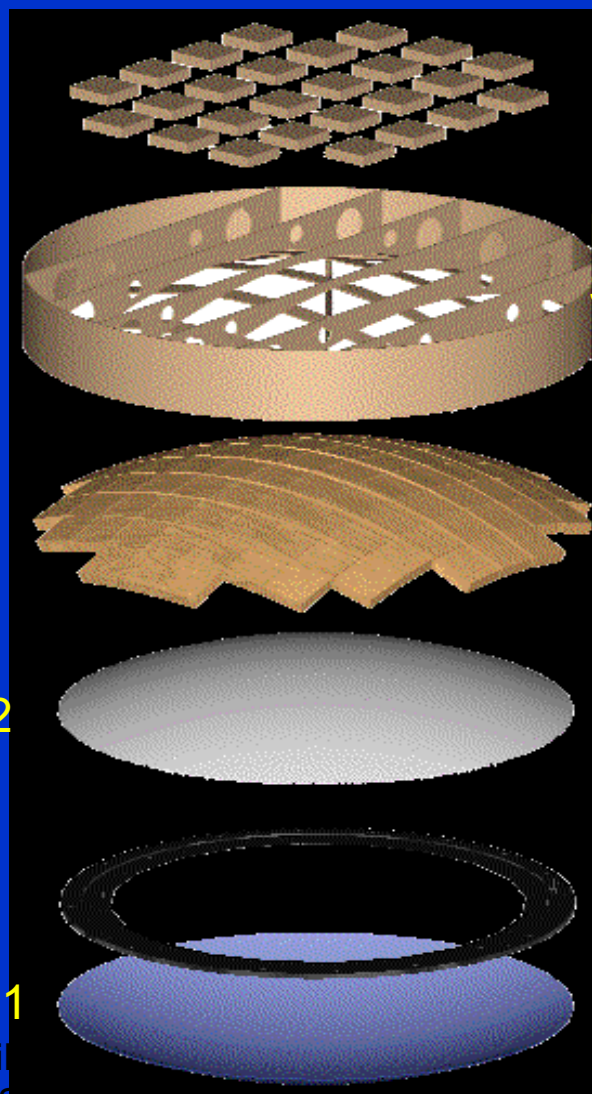
Power 1,060W

Weight 1,500kg



Fresnel Lens 2

Fresnel Lens 1



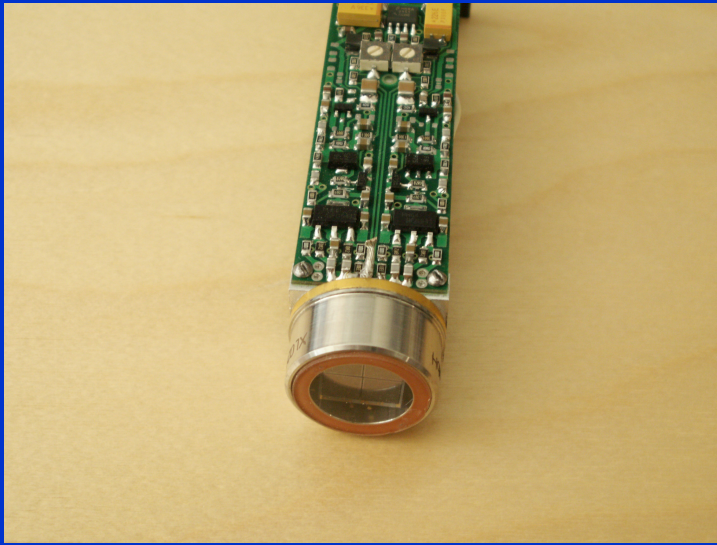
Electronics

Focal Surface
Support Structure

Focal Surface

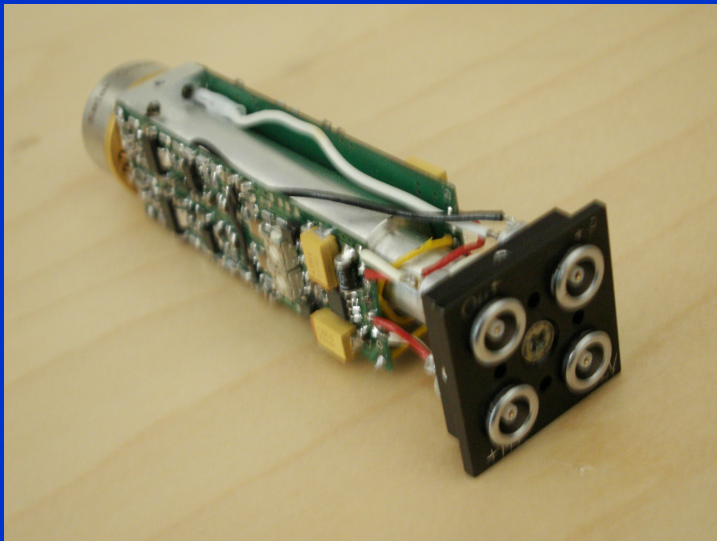
Entrance
pupil

A „pixel“ for MAGIC; 4 SiPMs of 5x5mm² size

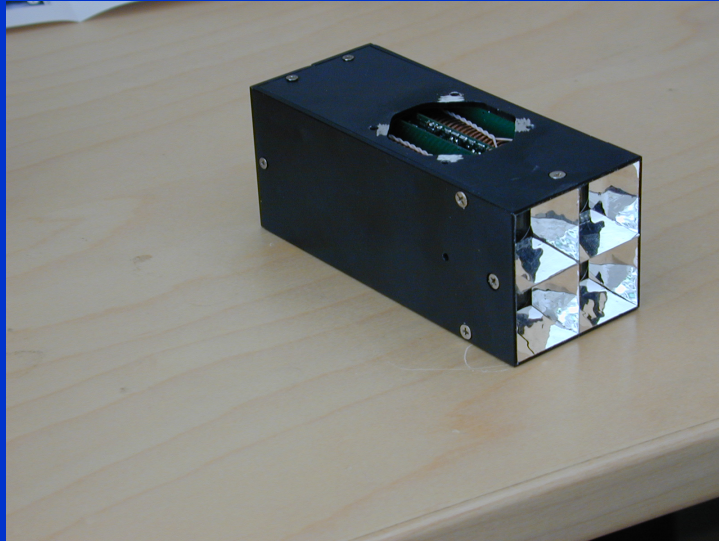


The pixel includes:

- 4 SiPMs of 5mm x 5mm size in an evacuated encasing
- signal amplifier-shaper
- 2-stage Peltier cooling system
- Winston cone type light concentrator
- metallic encasing with lemo connectors



The next step: 4-pixel unit each consisting of 4 SiPMs of 5mm x 5mm size

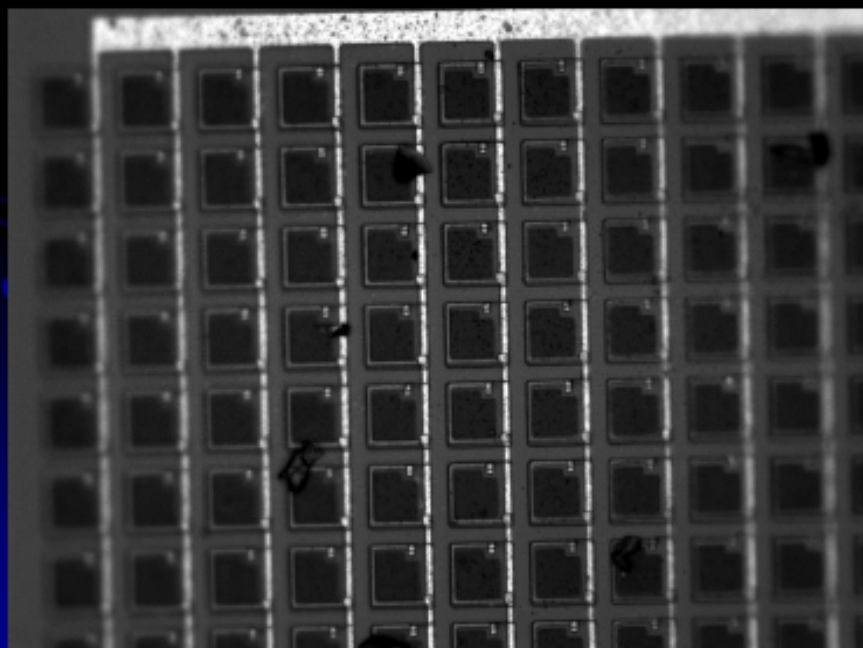
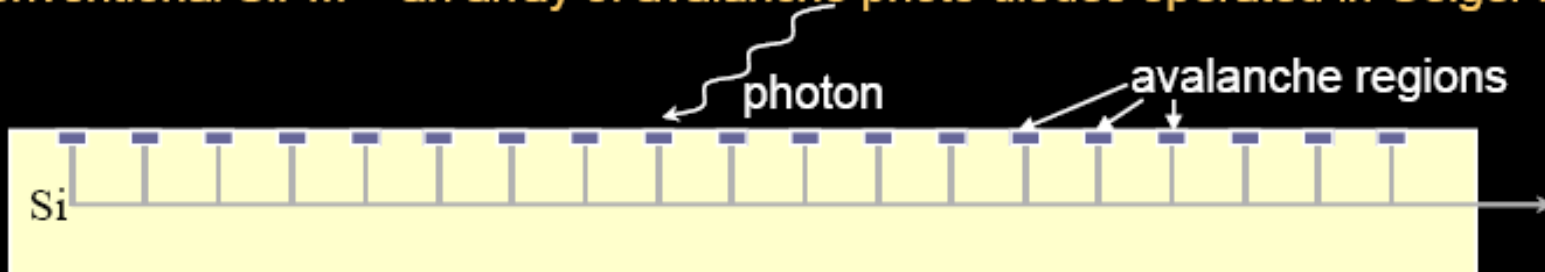


- This „autonomous“ unit needs just to get the necessary power connections and is fully operational
- It is rather straightforward to construct an imaging camera from such modules

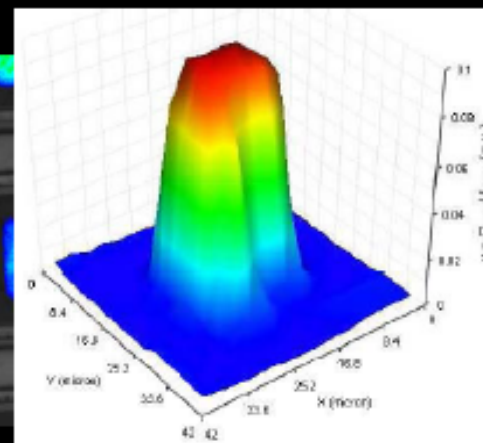
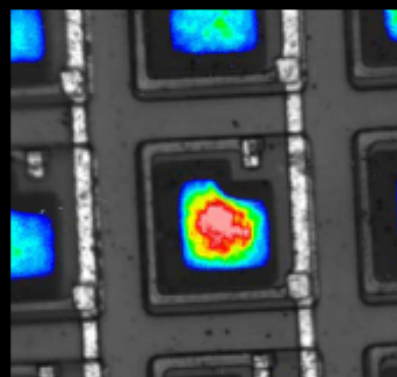


SiPM: novel light sensors

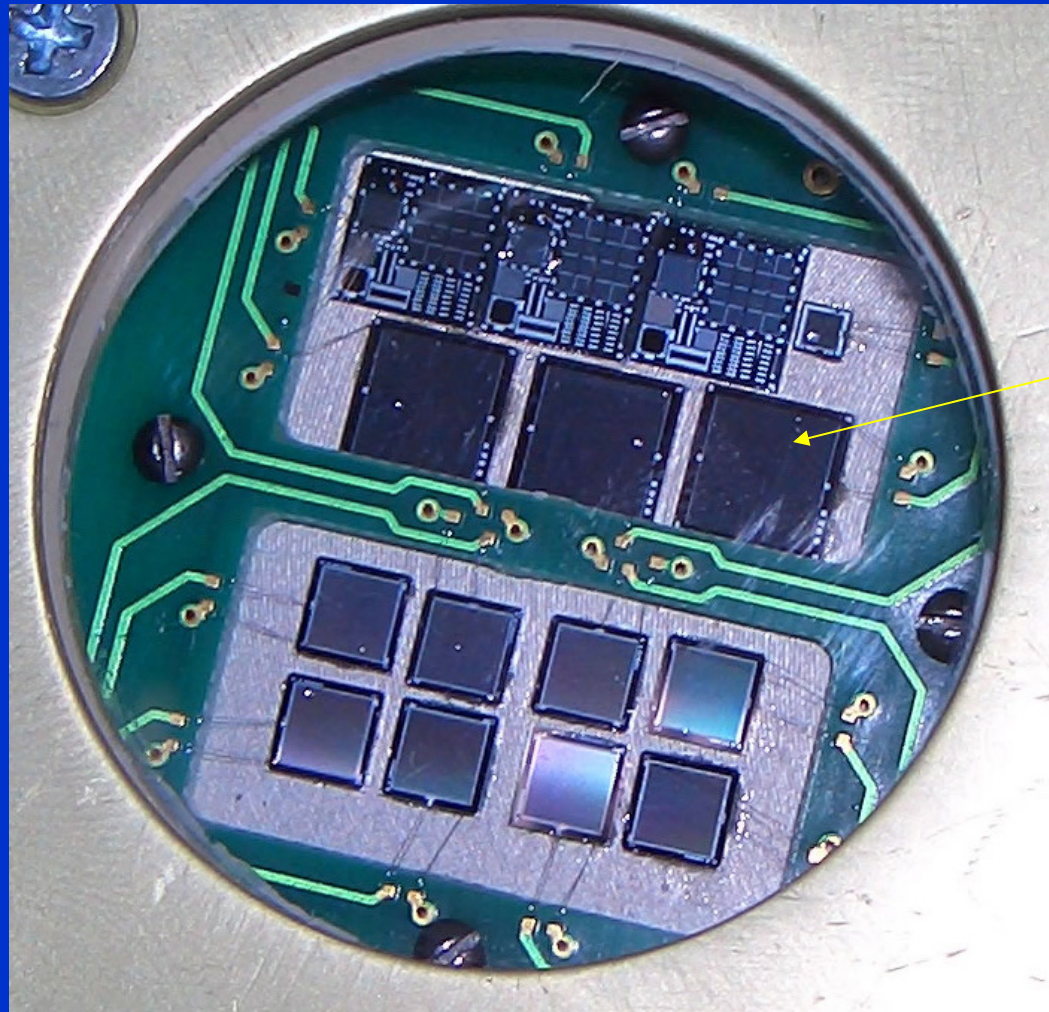
Conventional SiPM - an array of avalanche photo diodes operated in Geiger mode



Dolgoshein device



SiPMs: MEPhI-MPI development: 1x1, 1.3x1.3, 1.4x1.4, 3x3, 5x5 mm²



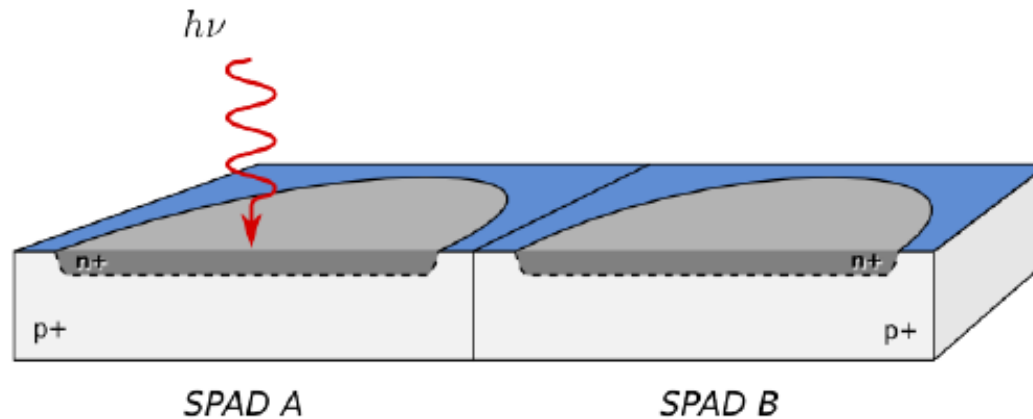
5 x 5 mm²

Why the light emission from Si avalanches is important

- First observation of the light emission from reversed-biased Si p-n junction in 1955 (Newman)
- Revived interest about the effect in recent years because of:
- Cross-talk in SiPMs (GAPD, MPPC, micro-channel APD,...) spoils the amplitude resolution
- The light emission is proportional to the number of e^- in the avalanche. This puts a limit to the maximum gain under which one can operate the SiPMs
- If no measures are taken against the cross-talk, then the F-factor is worse than in classical PMTs
- As a consequence one encounters major problems in self-trigger schemes when measuring very low light level signals

Cross-Talk

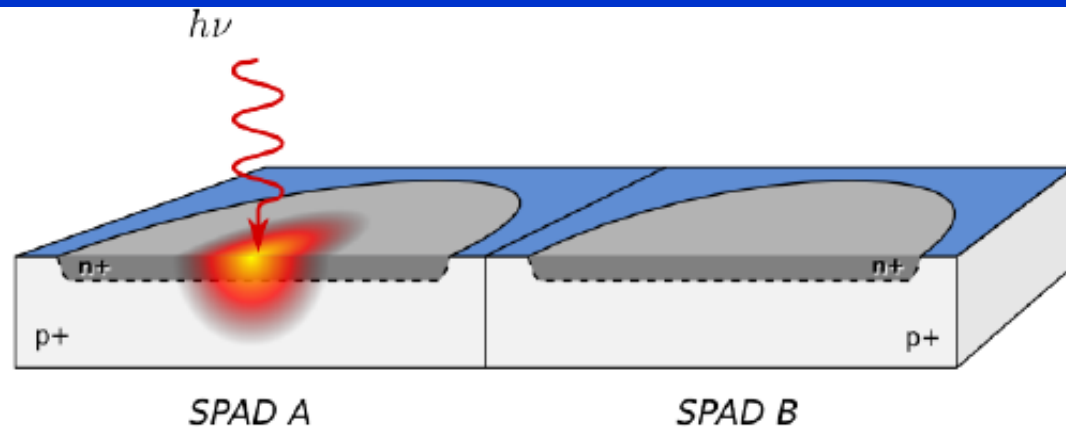
Ingargiola NDIP-08



When an avalanche is triggered in one SPAD we have:

- Secondary photons **emission** due to the avalanche current
- Photons **propagation** throughout the chip
- Secondary photon **detection** by a nearby detector

Cross-Talk

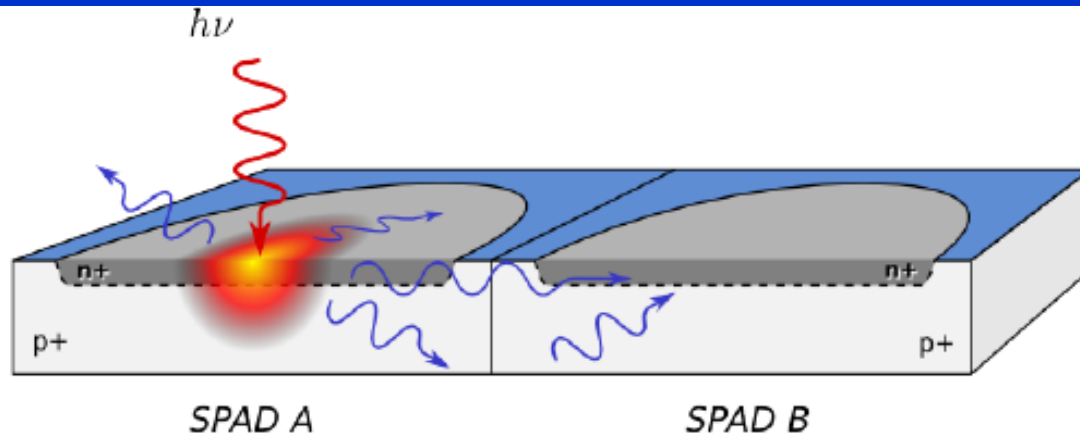


Ingargiola NDIP-08

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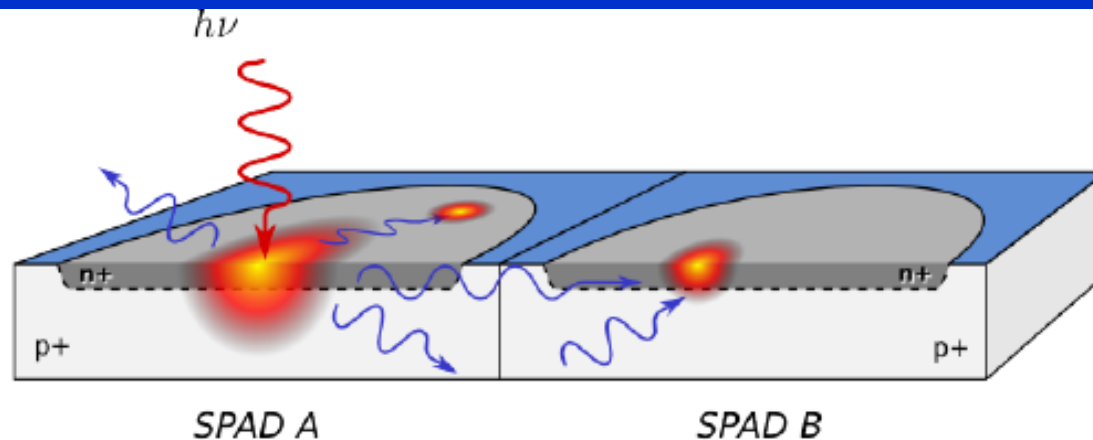


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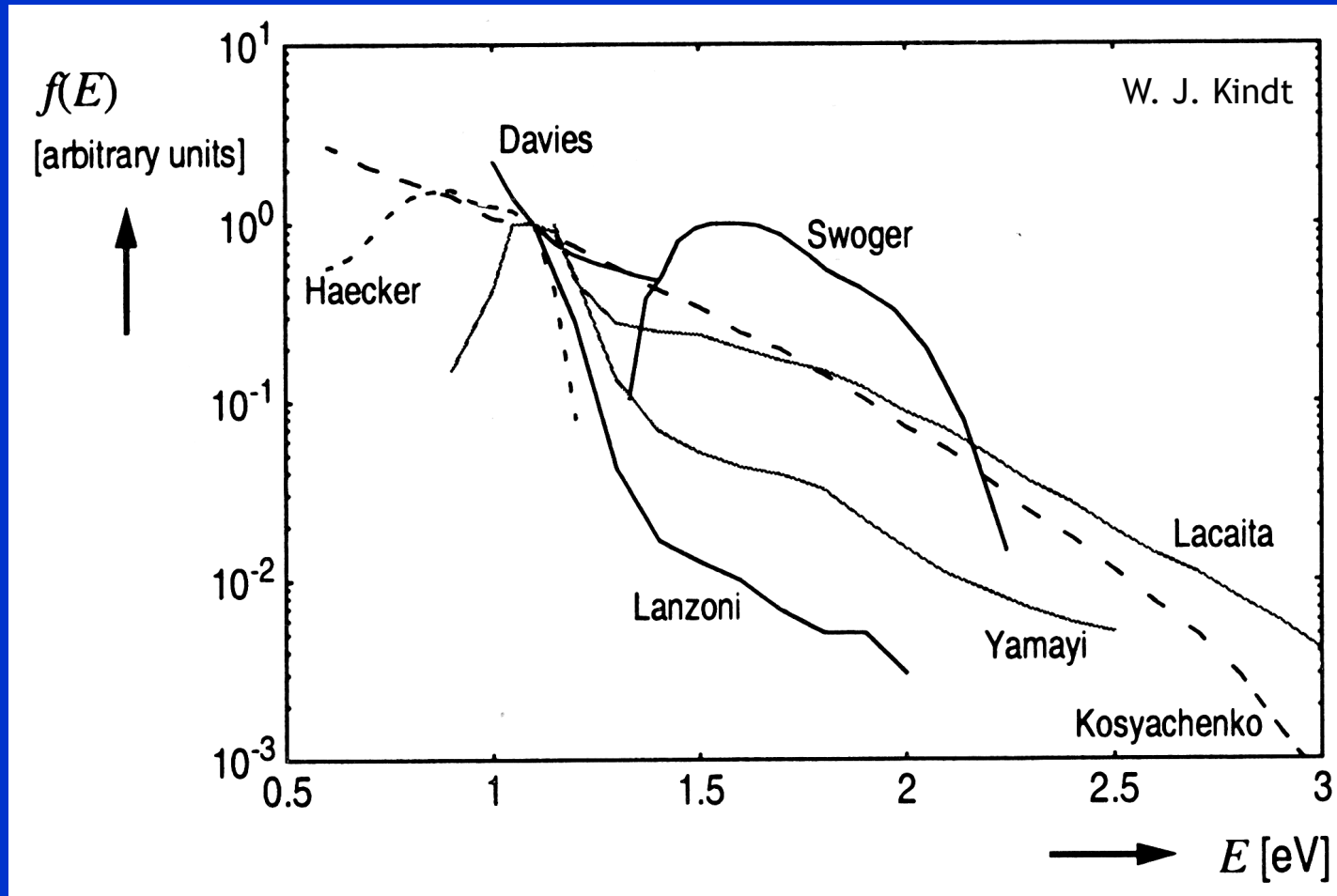


Ingargiola NDIP-08

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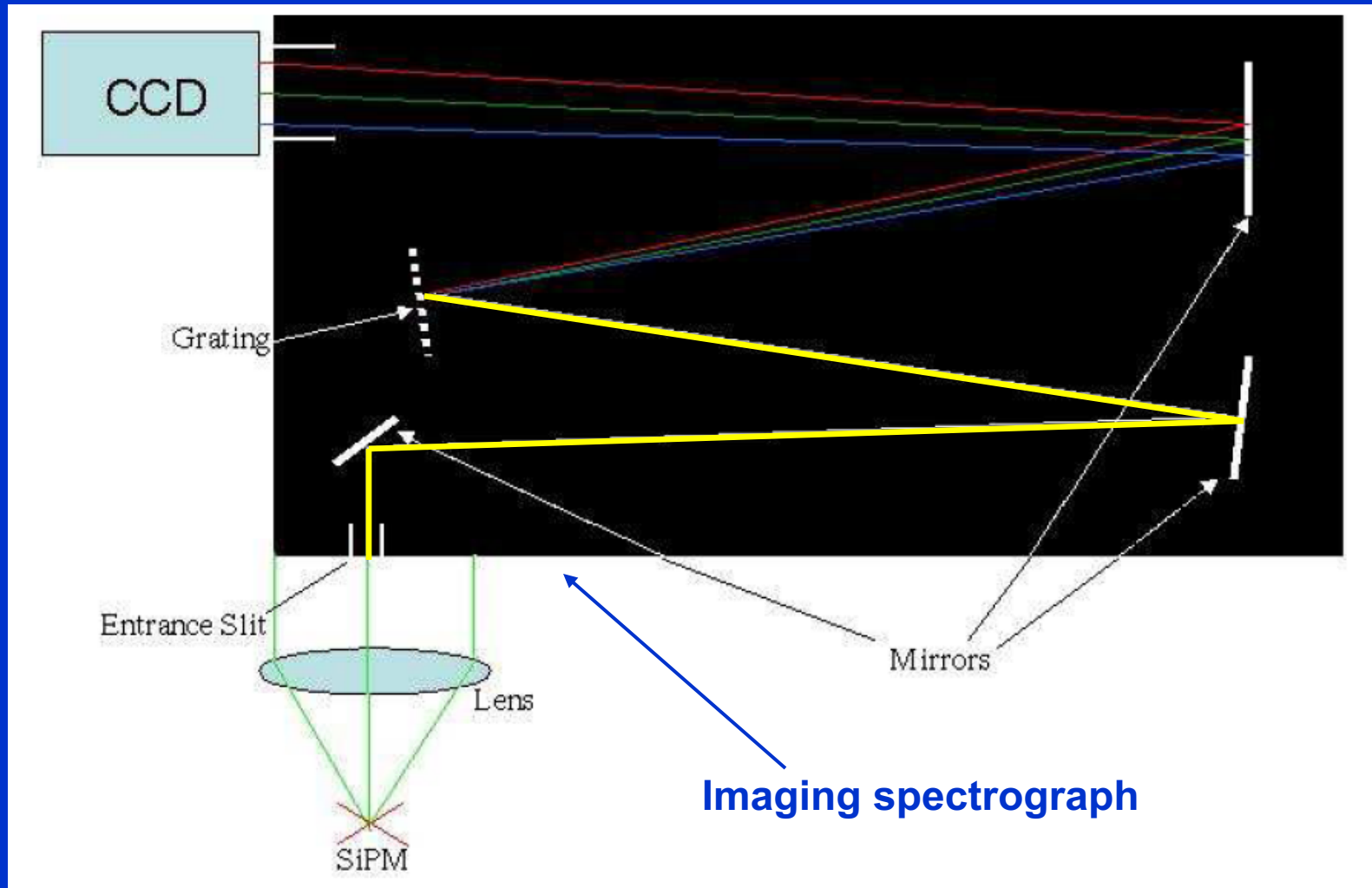
Light Emission in Si Avalanches: collection of different measurements



The Setup

- List of the components used in our setup:
 - (SiPM) MPPC *S0362-11-100U* from Hamamatsu
 - Imaging Single ph.e. Sensitive Spectrograph *Shamrock 303i* from Andor
 - CCD-camera *Idus 420 OE* for optical spectrum 450-1000nm
 - InGaAs –camera *DU490 A-1.7* from Andor for NIR spectrum 900-1700nm

Sketch of the experimental setup



Parameters of the setup

CCD pixels (row x column)	1024 x 256 (VIS) 512 x 1 (NIR)
Preamplifier gain CCD	14 e/count (VIS) 300 e/count (NIR)
Grating, lines/mm	150
Blase wavelength of grating	800nm
Slit size	2.5mm
Focal lenth of lens	50mm
Used gain of MPPC	1.56×10^6
Calibrated diodes	Si PIN and GaAs diodes
Number of used calib. LEDs	14 (470 – 1700)nm

The Absolute Calibration

- 14 different LEDs were used for the absolute calibration. They were grinded flat, polished and installed in the same position as the SiPM, in the focus of the lens. The CCD had absolute calibration. Then 2 measurements were done:

1- the LED light was measured by the CCD

2- the same light was measured by a calibrated PIN diode just behind the slit

The amount of light emitted by the SiPM was measured from the known geometry. The tabulated values of the refraction index in Si and SiO₂ were used in order to calculate the emission solid angle.

The Absolute Calibration

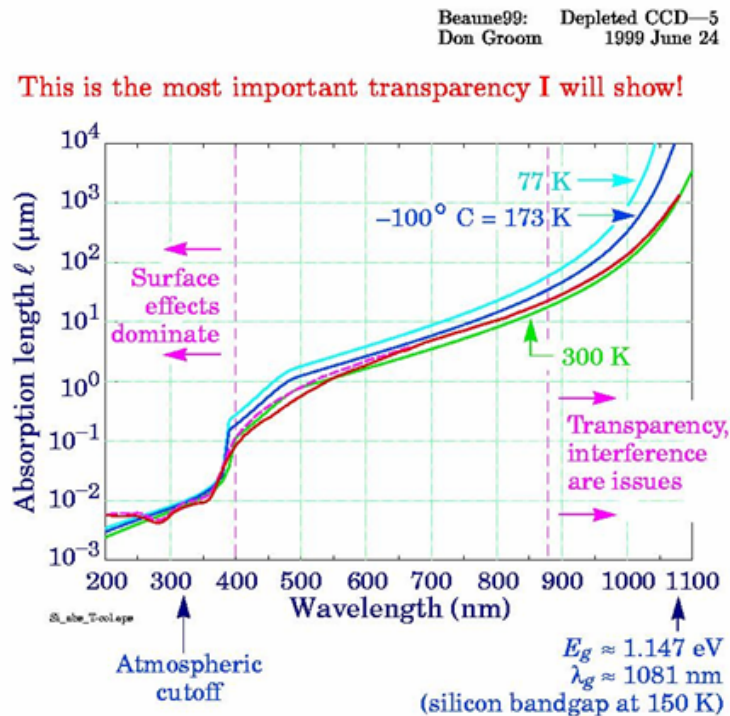
It was assumed that the used type of MPPC from Hamamatsu had an active zone of $1.8\text{ }\mu\text{m}$ in depth.

- The emitted light absorption in Si was simulated by using a simple Monte Carlo with a step size of $0.1\text{ }\mu\text{m}$ in depth. Tabulated values of the light absorption in Si were used for this calculation.
- Light reflection on the interface Si-SiO₂-air has been taken into account

The calibration LEDs

VIS LED, nm	470	520	621	700	750	810	910	1020
NIR LED, nm	910	1020	1200	1300	1450	1550	1600	1700

Reminder: light absorption in Si



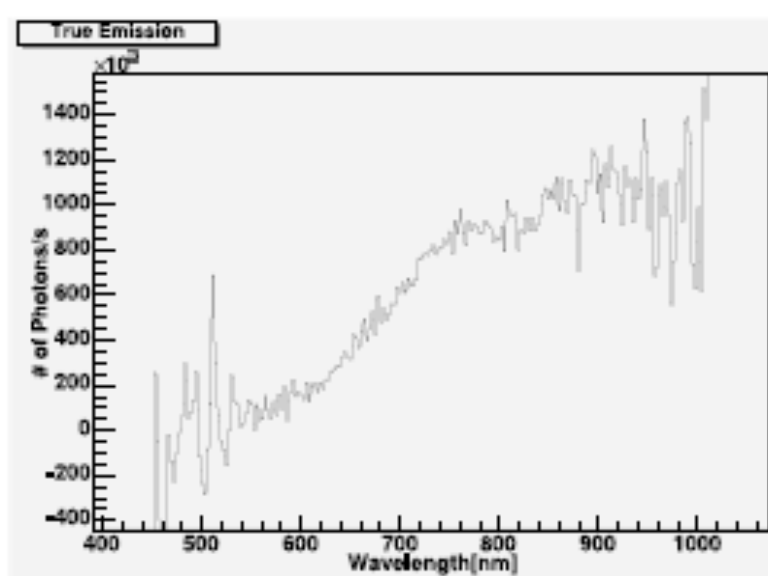
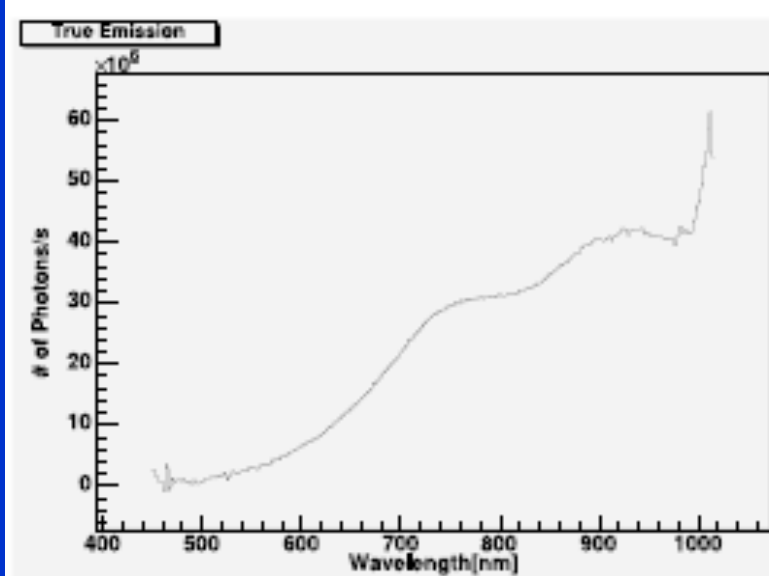
For the long wavelength end, temperature is important

Astronomical CCD's operate near -100° C to achieve noise-limited performance

Red curve is empirical; other curves are calculated from phenomenological fits by Rajkanan *et al.*

- The related to absorption effects in Si were taken into account in our measurements
- Already from this graph one can get an impression about the relevant for the cross-talk effect wavelength range

Measured spectrum in visible



It was difficult to measure the light emission signal in the NIR because of a) high noise level, b) the InGaAs CCD had only 512x1 pixels. To overcome this at 1st the signal in the VIS was measured directly by integrating the signal from 256 rows operating the MPPC under the gain of 1.56×10^6 .

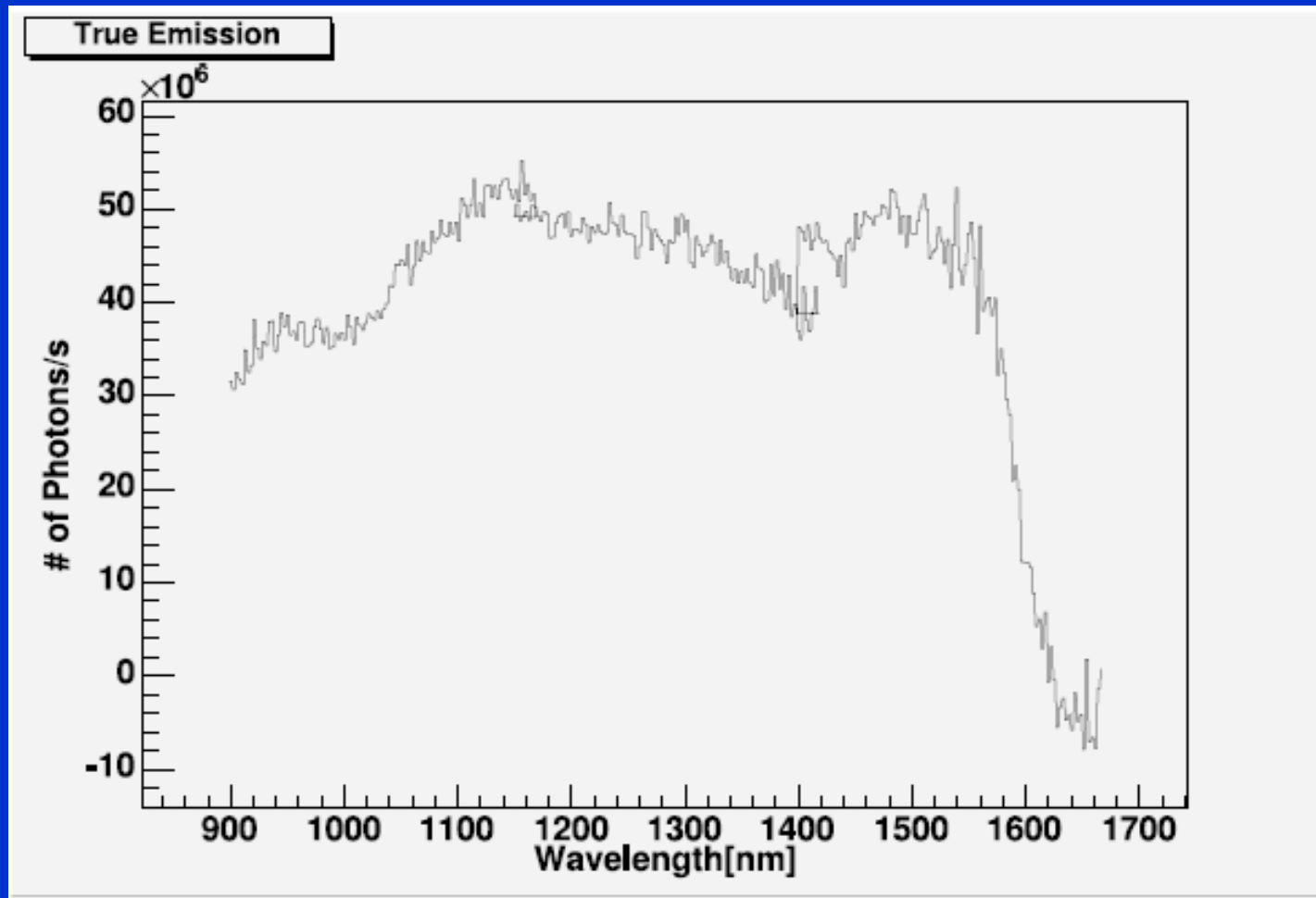
Controlled increase of the light emission in NIR

In order to amplify the light emission the MPPC was illuminated by an ultra-fast semiconductor laser ($\lambda=440\text{nm}$, $\tau=80\text{ ps}$) at 2.5 MHz, producing an average amplitude of 13 ph.e. in the matrix of 100 pixels (the dark rate was about 0.6-0.7 MHz). In this way we achieved an emitted light amplification of ~ 50 times.

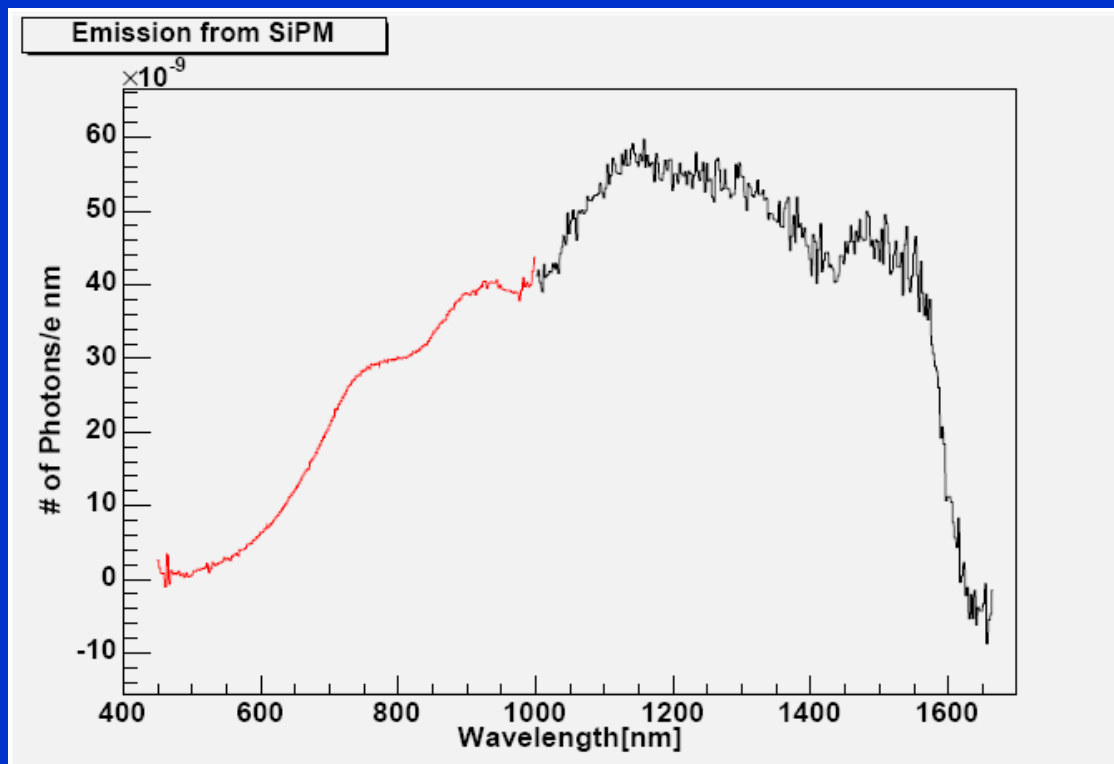
After that the applied voltage of the MPPC was increased putting it into a continuous trigger mode (no quenching) and the emitted light was again measured. By taking the ratio of the two measurements a scaling factor of 36.82 has been measured.

That factor was used to scale down the NIR emission to find out the emission rate at the used gain of 1.56×10^6 .

Measured spectrum in infrared



Entire emission spectrum



The largest error is
 $\leq 19.7\%$ for the „worst“
wavelength range
 < 600 nm

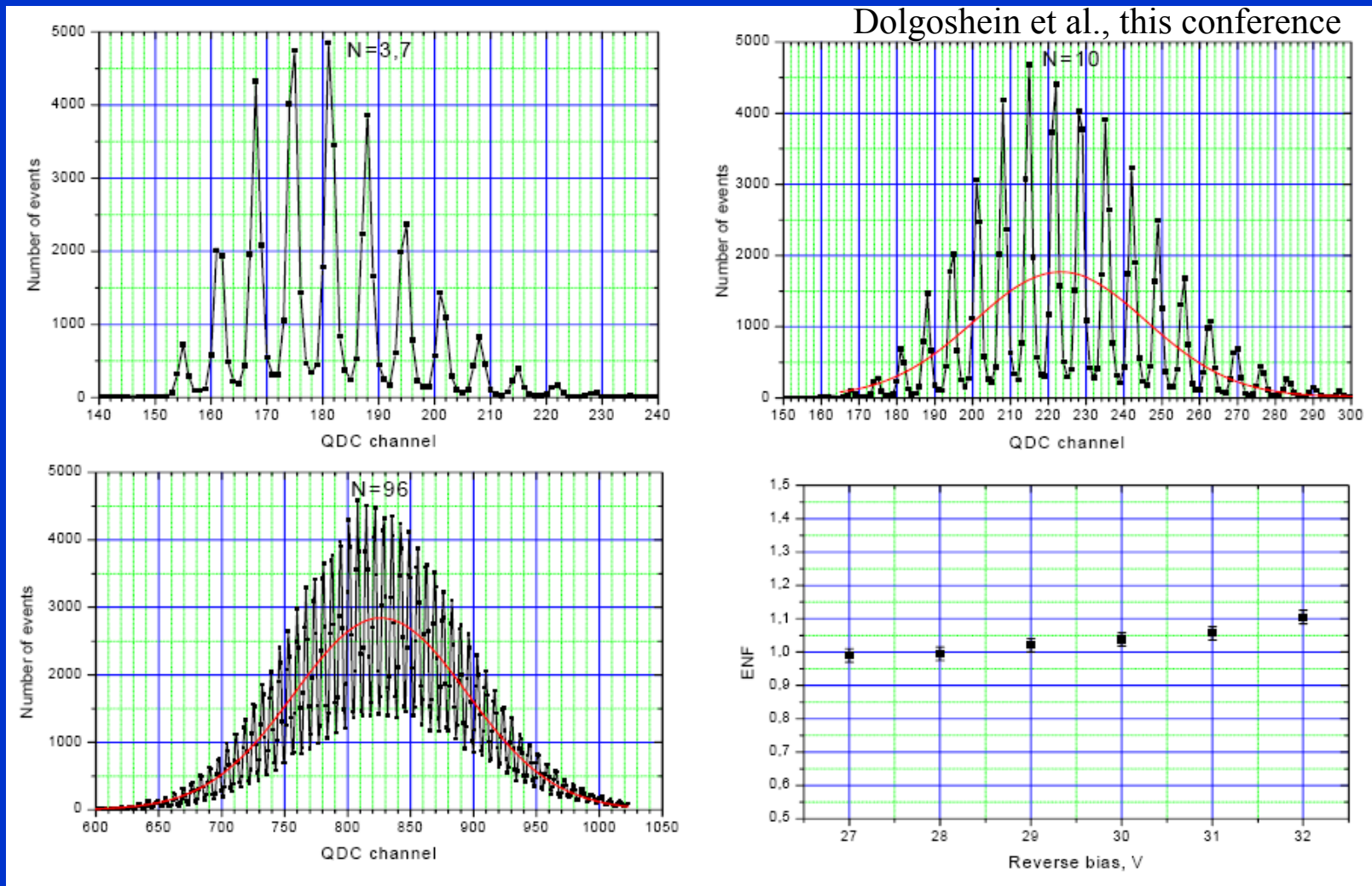
Wavelength range	450 – 1600 nm	< 1117 nm
This measurement	3.86×10^{-5} ph/e	1.69×10^{-5} ph/e
Lacaita, et al., 93		2.9×10^{-5} ph/e

Possible emission mechanisms

Akil et al., 1999, Villa et al., 1995, Bude et al., 1992, ...

- Interband transitions between hot e- and holes
- Direct intraband e- transitions, Bremsstrahlung radiation from hot e- scattered by charged coulombic centers, and phonon-assisted e- transitions
- Ionization and indirect interband recombination of e- and holes under high-field conditions
- Intraband transitions of hot holes between the light and heavy-mass valence bands

What can happen when the cross-talk is much suppressed

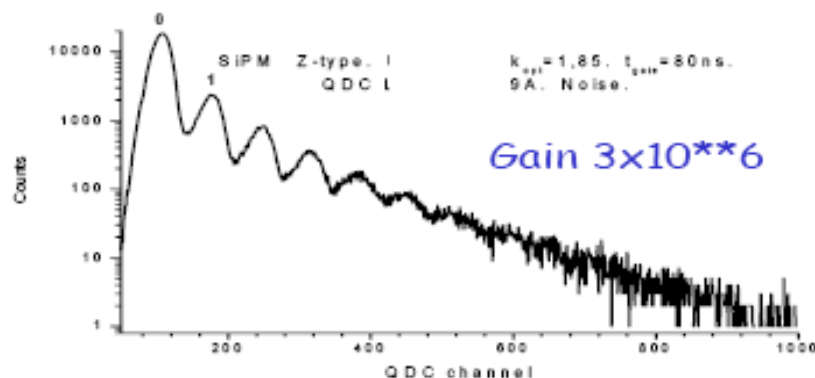


Short Summary

- In the 1st time we have measured the absolute light emission from an avalanche process in Si in the entire wavelength range 450-1600 nm.
- The measured value in the optical is in agreement with some selected measurements within factor of 2
- This measurement may help researchers in modeling the theory aspects of the light emission in Si avalanches
- This measurement may help researchers to better the design of SiPM matrixes as well as of (SiPM + scintillator) detectors

→ Long tail in SiPM pulse height distribution vs threshold

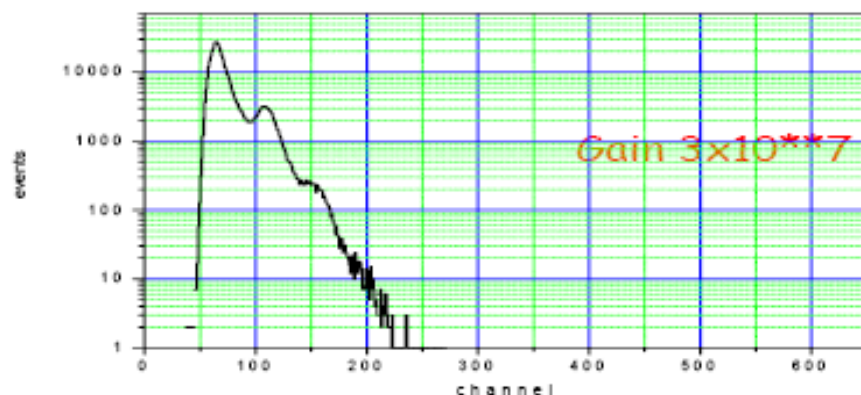
Optical crosstalk, SiPM 1x1 mm², dark noise



Crosstalk → non-Poissonian distribution:

pixel fired/phe=1.7

ENF=1.6



Crosstalk suppression by special SiPM topology:

Poisson distribution:

pixel fired/phe= ~1

ENF= ~1

Optical Crosstalk OC

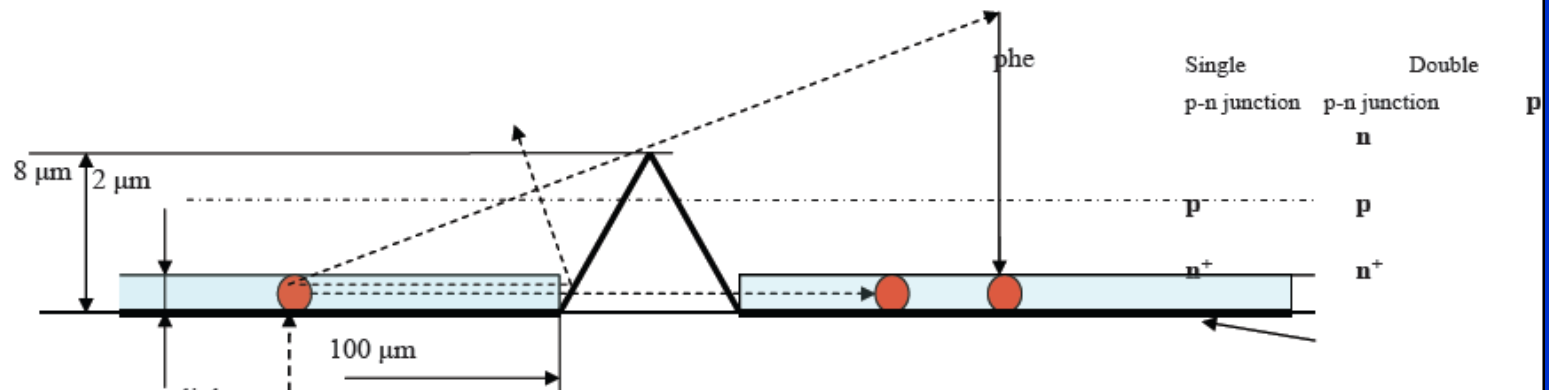
OC has two components

FIRST: phe's are induced in high electric field depletion region of neighbouring pixels

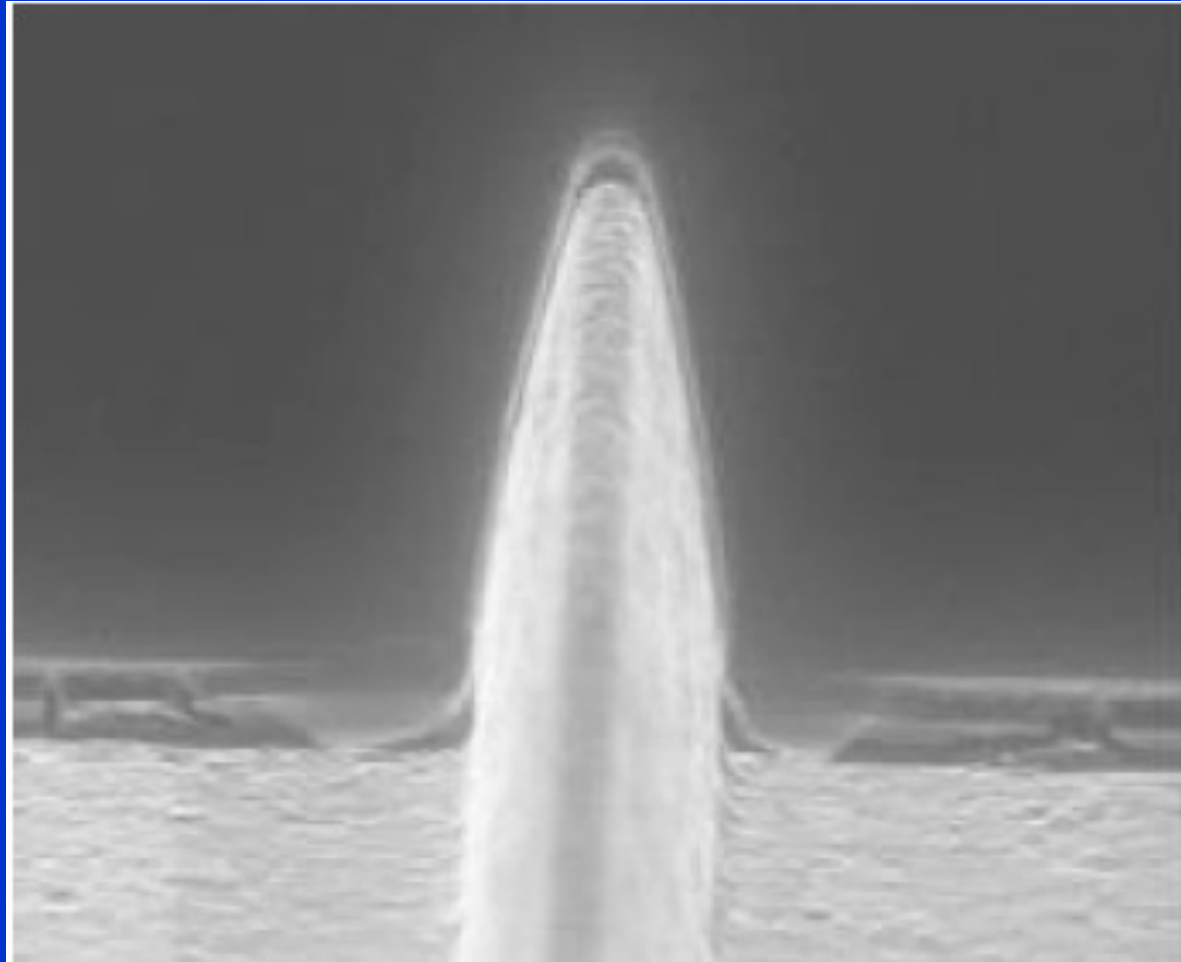
→ this mechanism is very fast: $\sim 1\text{ns}$ (prompt OC)

SECOND: The same in undepleted region and then the diffusion (or drift) to high electric field Geiger region of neighbouring pixels

→ this process is delayed: later than 1ns



A filled-in trench

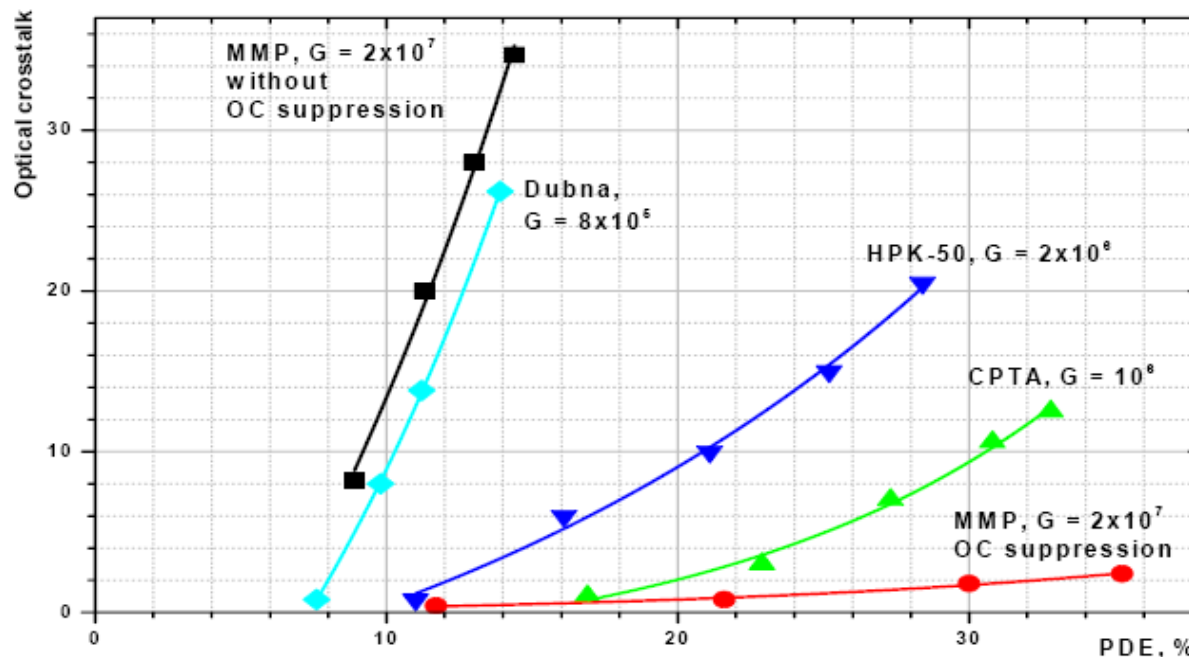


Comparison with other producers devices

-extracted from measurements made by Yu.Musienko,PD07,Kobe,2007

→ Let's define the Optical Crosstalk as

$$OC = N(\text{threshold} > .5 \text{ phe}) / N(\text{threshold} > 1.5 \text{ phe})$$



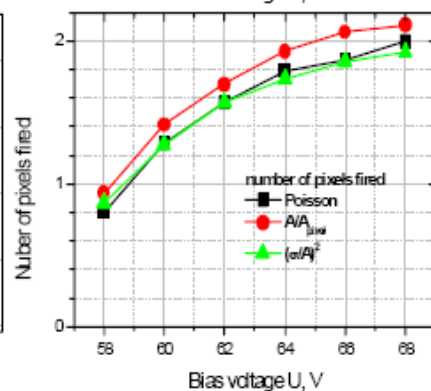
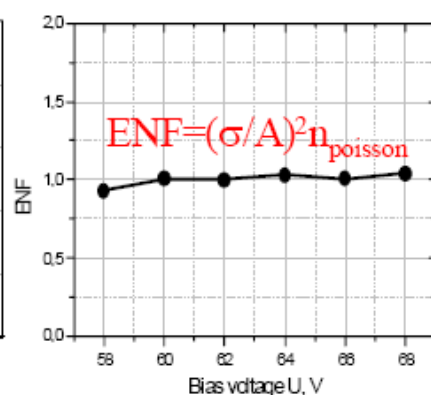
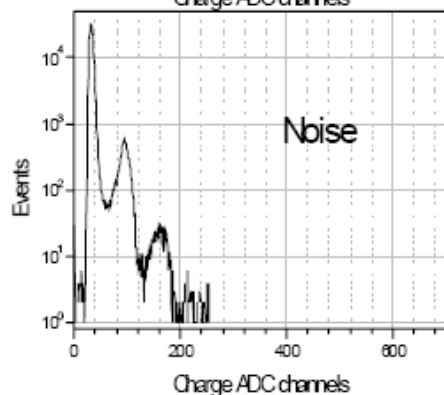
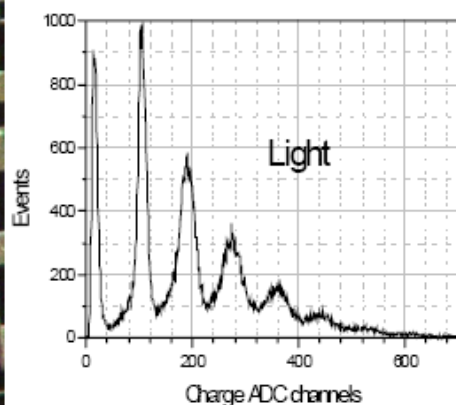
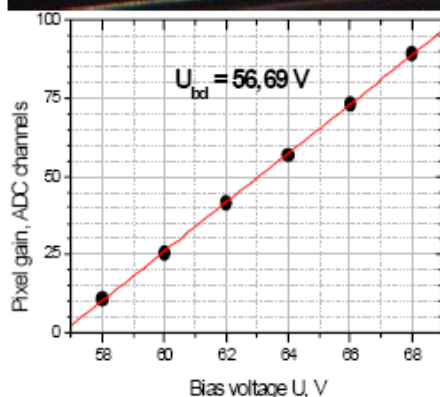
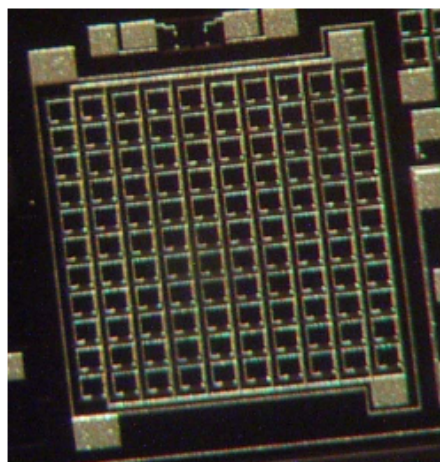
5x5 mm² SiPM: OC+AP($R_{\text{quench}} \times C_{\text{pix}} = .5 \text{ mks}$) = ~2.5%,
for PDE=36%, Gain+ 2×10^7

Production and performance of 5x5mm² SiPM for MAGIC telescope with suppression of OC and AP

MAGIC requirements discussed:

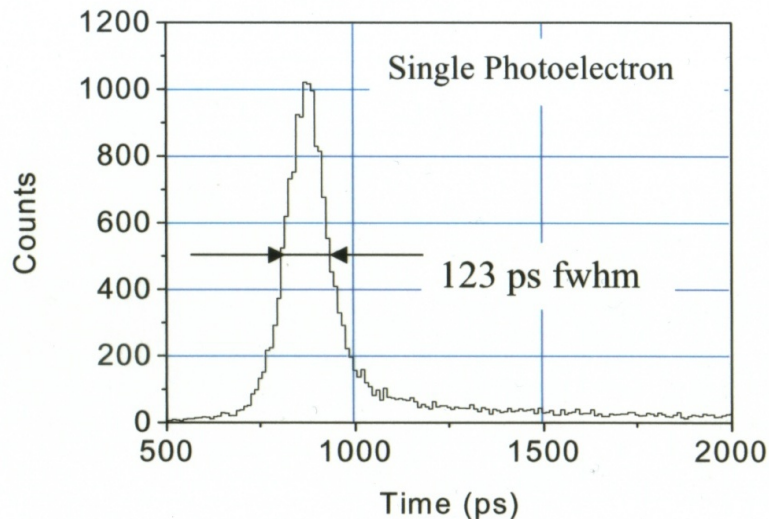
- one cell of photodetector plane with a photosensor matrix of 4(5x5mm²) SiPMs 2 cm²
1 cm²
- spectral response ~350-650 nm
- PDE: as much as possible(compared to PMT)
- Afterpulsing <1-2%
- Optical Crosstalk <5%
- single phe pulse width ~2ns
- dark rate: less than Light Of Night Sky(LONS)
= ~600 kHz/mm²
→ ~300 KHz/mm² or ~8 MHz/5x5mm²

First step: SiPM 1.4x1.4 mm² with OC suppression topology

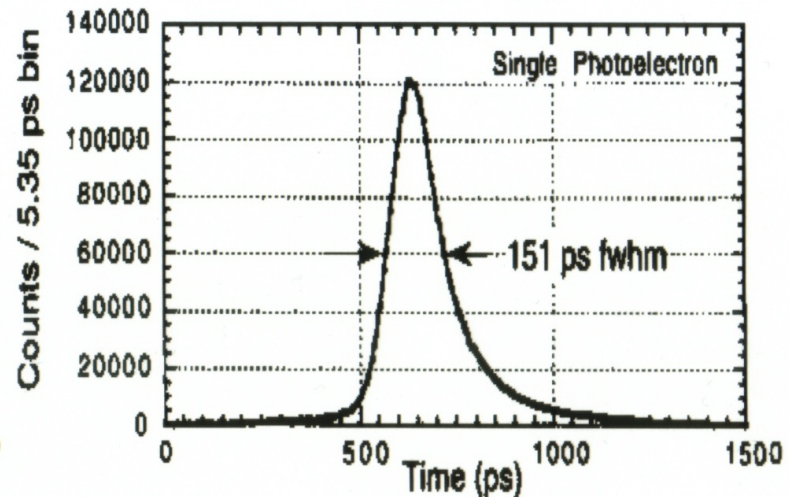


Timing by SiPM: possible application for Cherenkov Imaging Counters

SiPM



PMT R-5320



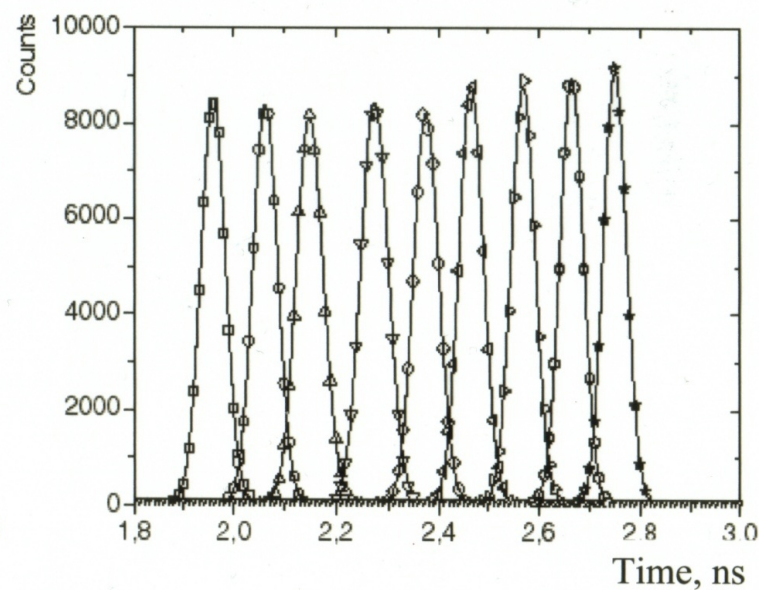
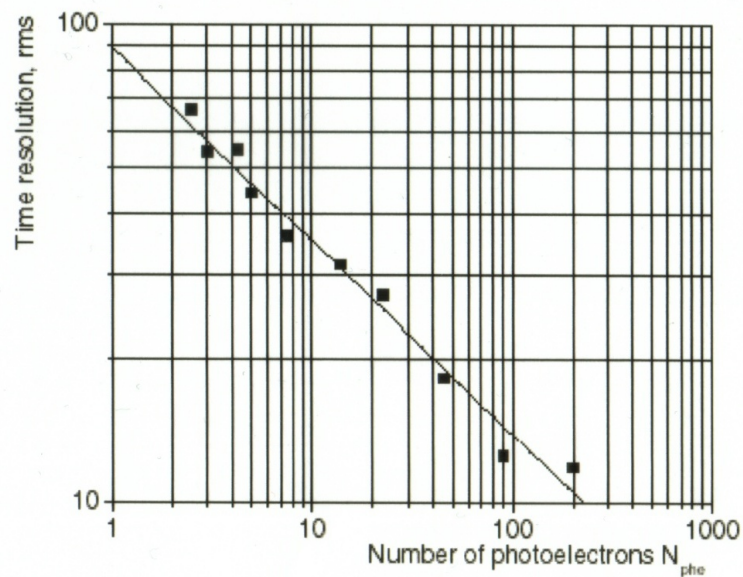
SiPM:

- position sensitive ($\sim 1 \text{ mm}^2$)
- a single photon detection capability with background hits density : $2 \cdot 10^{-3} \text{ 1/ns} \cdot \text{mm}^2$ (room temperature)
 $3 \cdot 10^{-4} \text{ 1/ns} \cdot \text{mm}^2$ (-50°C)

- insensitive to magnetic field
- good time resolution ($\sim 50 \text{ ns rms}$)

FWHM: Laser (40 ps) + electronics (60 ps) \Rightarrow SiPM (100 ps)

SiPM time resolution



Second step: 5x5mm² SiPM with OC and AP suppression

SiPM parameters:

→ size	5x5mm ²
→ double junction structure with optical barriers 6mkm	
→ number of pixels	1600
→ pixel size	100mkm
→ gain	2×10^7
→ geometrical eff.(filling factor)	64%
→ pixel capacitance	~1pF
→ output SiPM capacitance	~160pF
→ antireflection entrance window	
→ single pixel recovery time	~ .5mks

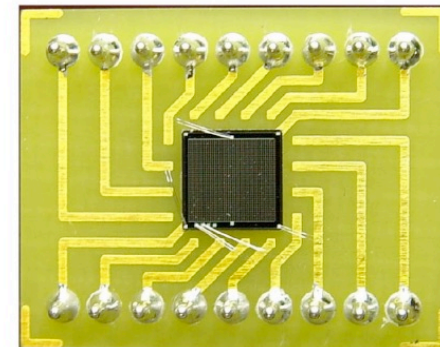
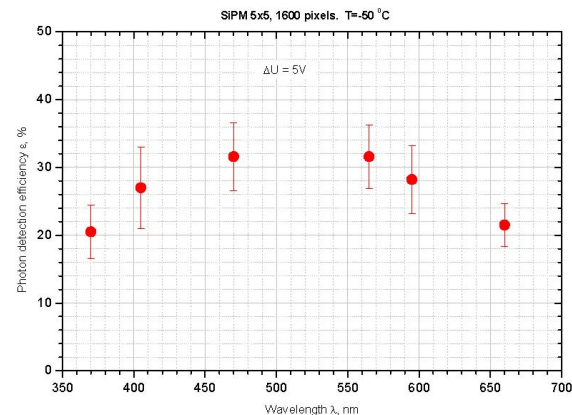


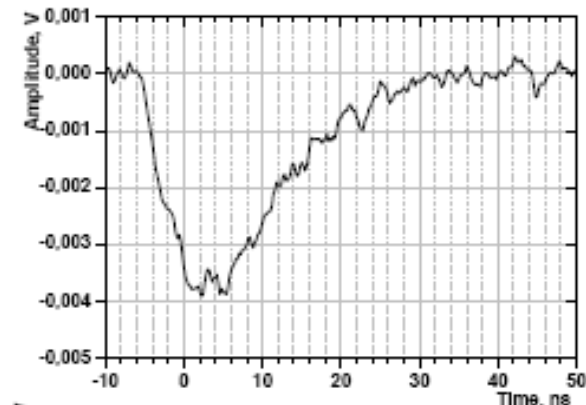
Figure 3: $25(5 \times 5)mm^2$ SiPM. It consists of the array of 1600(40×40) micropixels with $100 \times 100\mu m^2$ size.

Timing by 5x5mm² SiPM: signal shape

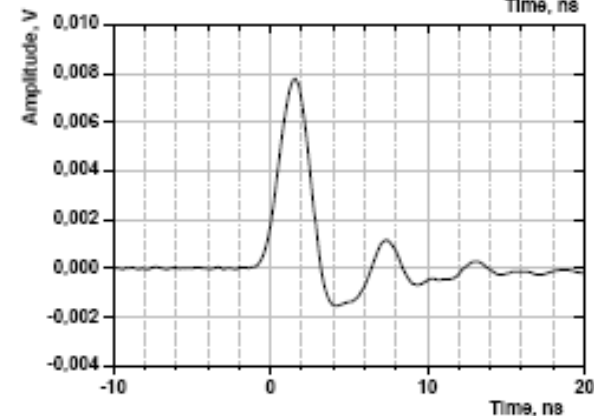
→ Because high SiPM output capacitance ($\sim 160\text{pF}$)

a special FE electronics has been developed:

low input impedance (a few Ohm)
current amplifier+shaper



50 Ohm
FWHM
15ns



$\sim 7\text{ Ohm}$
+shaper
FWHM
2,5ns

Optical crosstalk OC

One phe gives rise more than one pixel fired due to secondary photons
 $\sim 3 \times 10^5$ photons($\sim 1000\text{nm}$) per one electron in Geiger discharge

OC

- does not depend on temperature
- proportional to
 $\text{Gain} \times \text{Photon Detection Efficiency}$

The larger PDE
→ the larger pixel size
→ The larger Gain

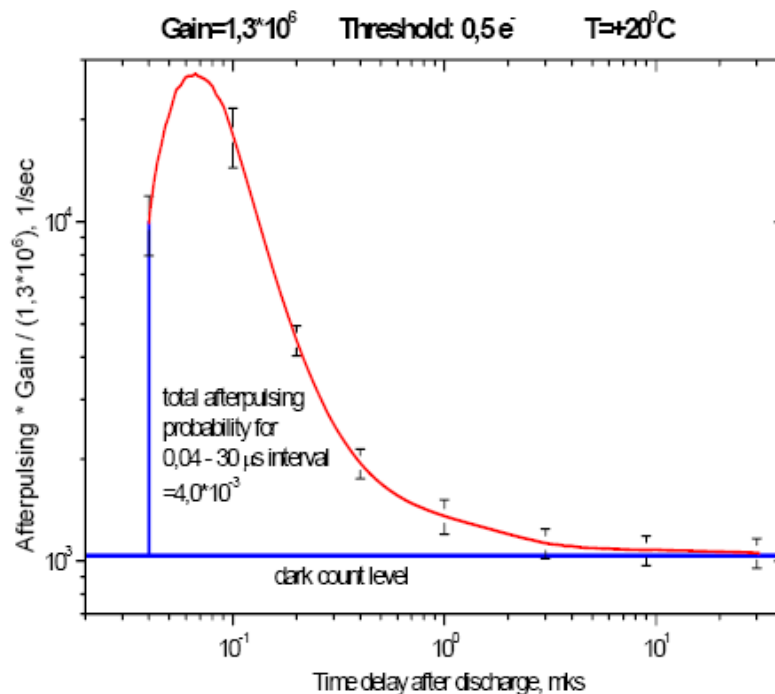
Afterpulsing AP

Capture of avalanche electron by traps and its delayed release giving the secondary Geiger discharge in the same pixel

AP

- proportional to
 $\text{Gain} \times \text{PDE}$
- increases for low temperature the same recovery time because trap lifetime increase

→ The lifetimes of trapped electron are mostly rather small:
less than ~100 ns



Therefore a single pixel recovery time $R_{quench} \times C_{pixel}$ should not be not very small and recommended at level of .5-1 mks

→ Even for high Gain x PDE the Afterpulsing has to be small enough:
 $AP(\text{Gain} = 10 \times 7) = \sim 1\%$
for recovery time of $> 500 \text{ ns}$

→ Give rise the non-Poisson statistics of fired pixels (SiPM response).

→ As a result:

→ SiPM pulse height resolution is worsening:

→ $(\sigma/A)^2 > 1/N$ phe

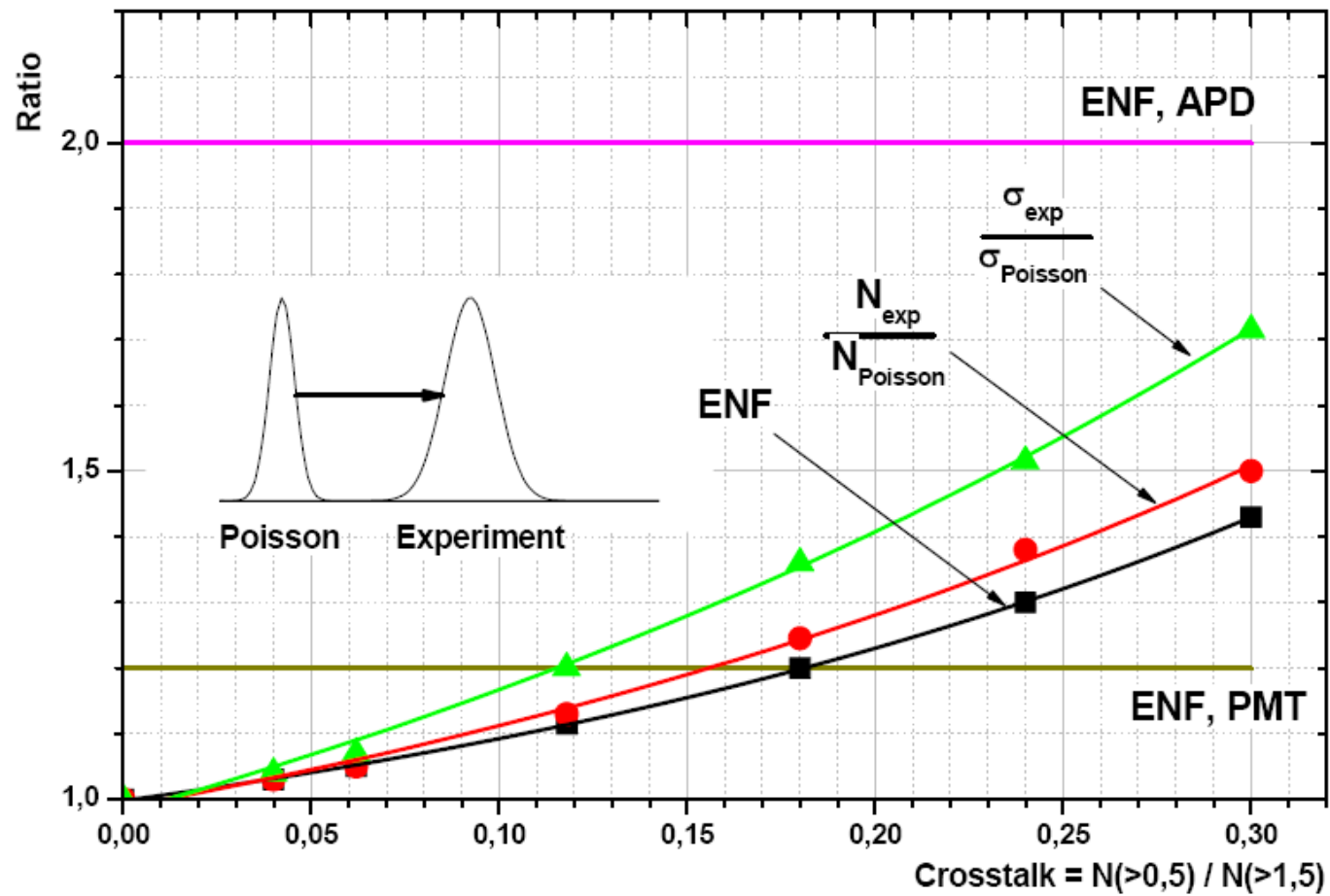
Excess Noise Factor ENF > 1

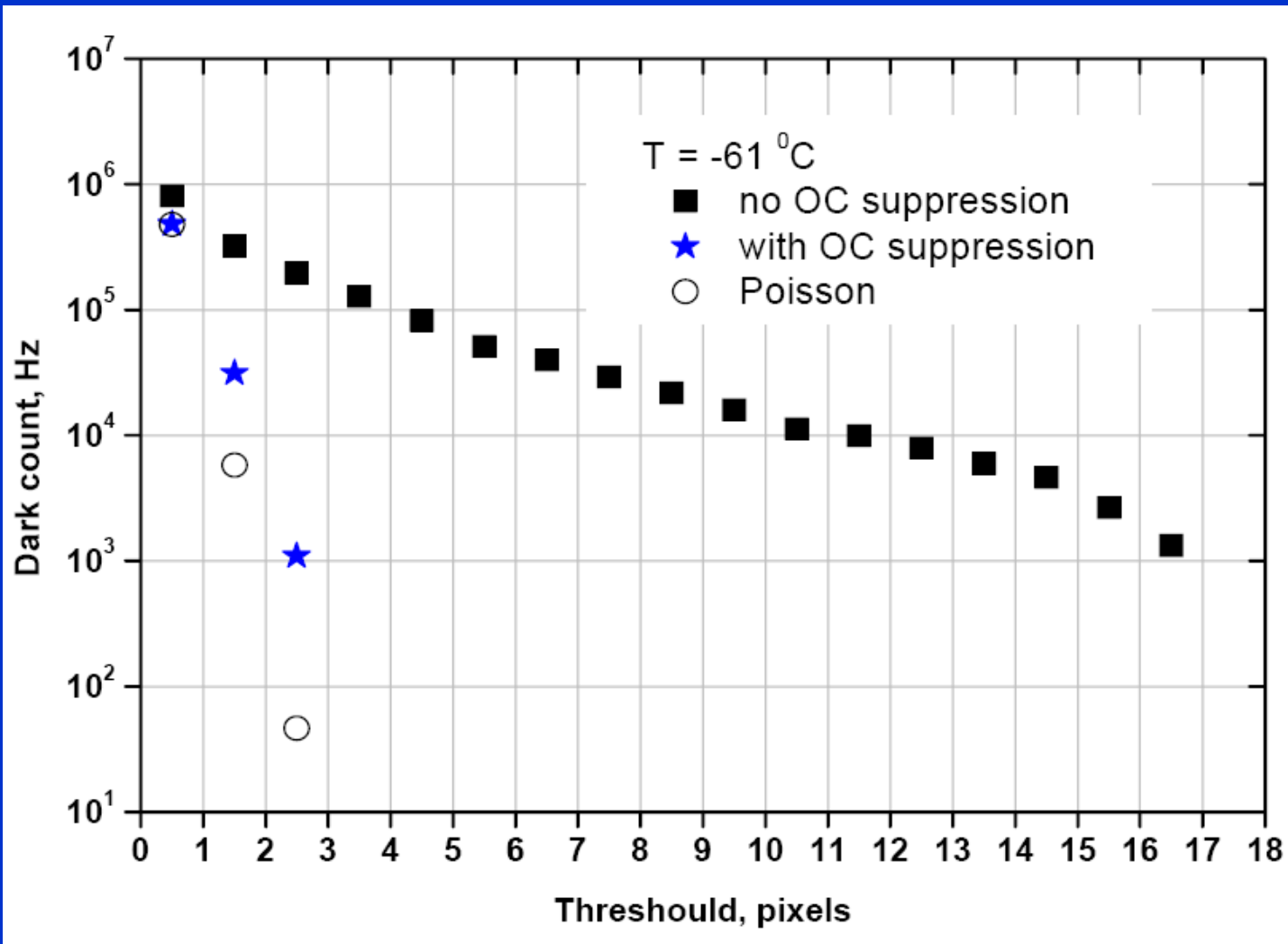
→ Sci Spectrometry(PET etc.) ?

ENF: for PMT ~ 1.2

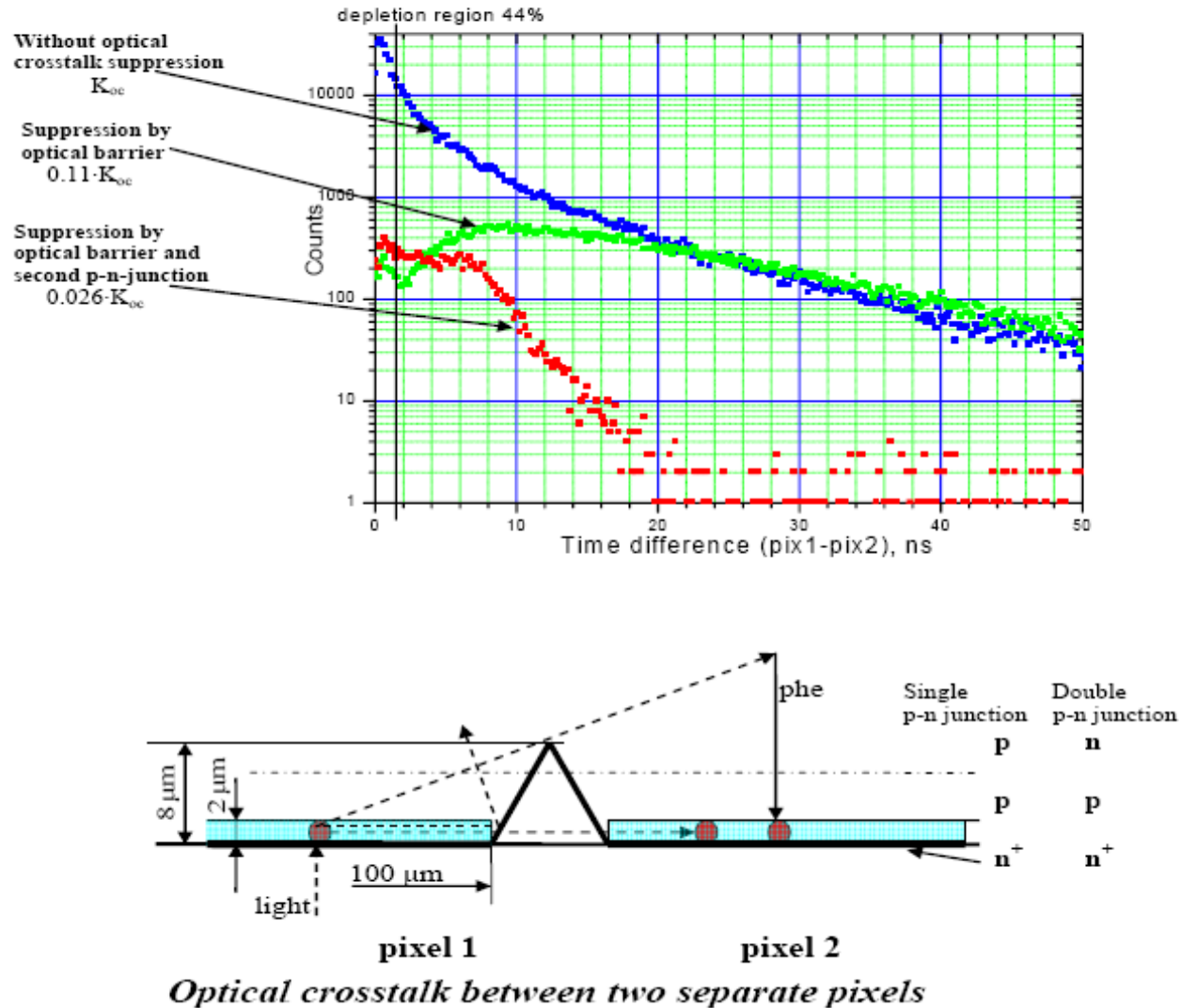
 for APD ~ 2-2.5

 for SiPM(desirable) < 1.05





Optical Crosstalk studies



Results of Optical Crosstalk studies

two separated pixels
pixel size 100 μ m, pitch 130 μ m
gain 2×10^7
recovery time > 1mks
PDE=35%

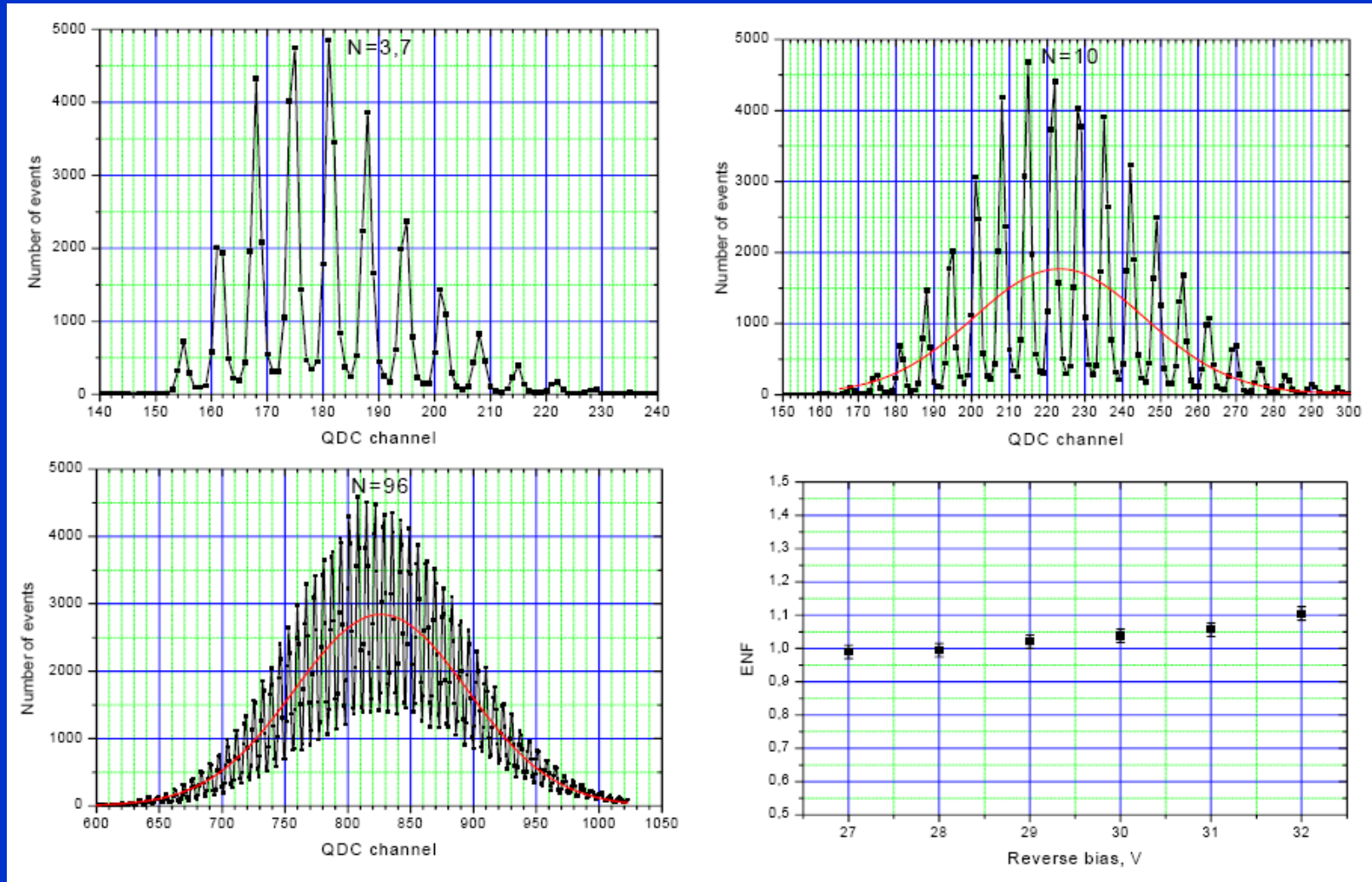
OPTICAL CROSSTALK:

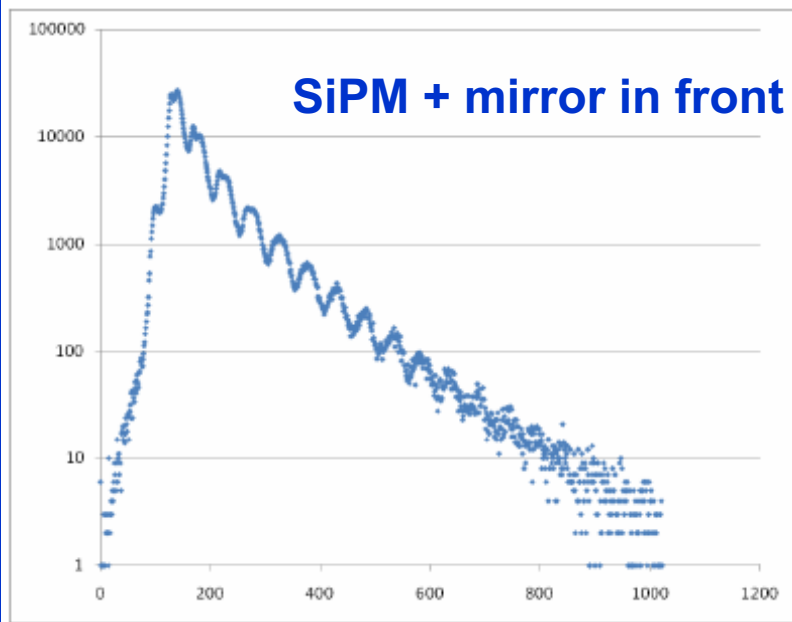
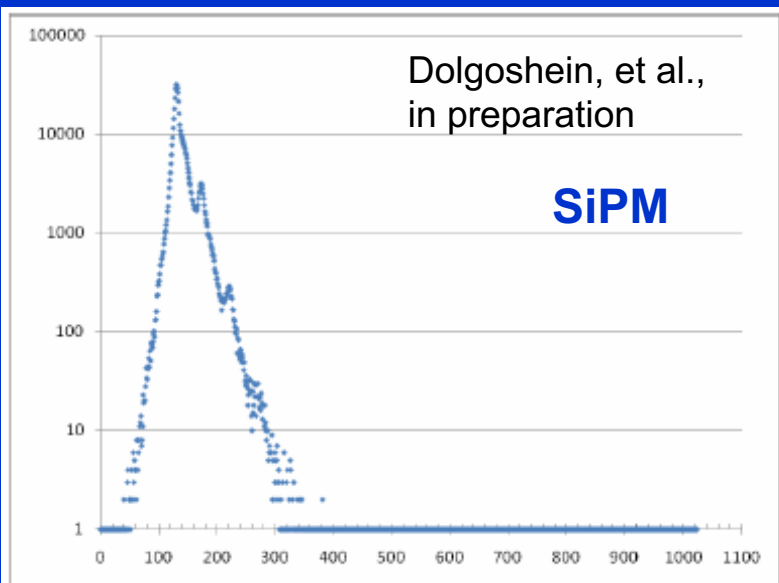
- prompt (< ~1ns. phe in depletion region) ~50%
- delayed(> ~1ns
~50%)

OPTICAL CROSSTALK SUPPRESSION FACTOR:

- with optical barriers(tranches, 8 μ m deep) ~9
- with optical barriers + second n-p junction ~4.5
- Total: ~40

SiPM with cross-talk suppression: World record of ultra-fast light sensors in amplitude resolution





- A curious experiment: what will happens if one will hold a mirror in front of a SiPM ?
- The emitted light bounces back strongly amplifying the cross-talk effect
- Similarly the amplitude resolution shall degrade when SiPMs are coupled to scintillators (Dolgoshein et al., under preparation)

Conclusions

- The optical cross-talk has strong impact on SiPM seriously degrading its performance
- We have developed successful measures against it (trenches + double junction)
- The SiPM is on the way of becoming (almost) an ideal LLL sensor within next 2-3 years
- Within the next several years we will observe how they will replace the APDs and the PMTs from many „classical“ applications, including those in life sciences and probably, also in medicine
- Still they are expensive because of the monopoly of essentially one big producer